

## FEATURES

**8-channel, configurable ADC/DAC/GPIO**

**Configurable as any combination of**

**8 × 12-bit DAC channels**

**8 × 12-bit ADC channels**

**8 × general-purpose digital input/output pins**

**Integrated temperature sensor**

**SPI interface**

**Available in**

**16-ball, 2 mm × 2 mm WLCSP**

**16-lead, 3 mm × 3 mm LFCSP**

**16-lead TSSOP**

## APPLICATIONS

**Control and monitoring**

**General-purpose analog and digital inputs/outputs**

## GENERAL DESCRIPTION

The **AD5592R/AD5592R-1** have eight I/Ox pins (I/O0 to I/O7) that can be independently configured as digital-to-analog converter (DAC) outputs, analog-to-digital converter (ADC) inputs, digital outputs, or digital inputs. When an I/Ox pin is configured as an analog output, it is driven by a 12-bit DAC. The output range of the DAC is 0 V to  $V_{REF}$  or 0 V to  $2 \times V_{REF}$ .

When an I/Ox pin is configured as an analog input, it is connected to a 12-bit ADC via an analog multiplexer. The input range of the ADC is 0 V to  $V_{REF}$  or 0 V to  $2 \times V_{REF}$ . The ADC has a total throughput rate of 400 kSPS. The I/Ox pins can also be configured as digital, general-purpose input or output (GPIO) pins. The state of the GPIO pins can be set or read back by accessing the GPIO write data register or the GPIO read configuration register, respectively, via a serial peripheral interface (SPI) write or read operation.

The **AD5592R/AD5592R-1** have an integrated 2.5 V, 25 ppm/°C reference, which is turned off by default, and an integrated temperature indicator, which gives an indication of the die temperature. The temperature value is read back as part of an ADC read sequence.

The **AD5592R/AD5592R-1** are available in 16-ball, 2 mm × 2 mm WLCSP, 16-lead, 3 mm × 3 mm LFCSP, and 16-lead TSSOP. The **AD5592R/AD5592R-1** operate over a temperature range of -40°C to +105°C.

**Table 1. Related Products**

| Part No.       | Description   |
|----------------|---|
| <b>AD5593R</b> | <b>AD5592R</b> equivalent with $V_{LOGIC}$ and $RESET$ pins and an I <sup>2</sup> C interface |

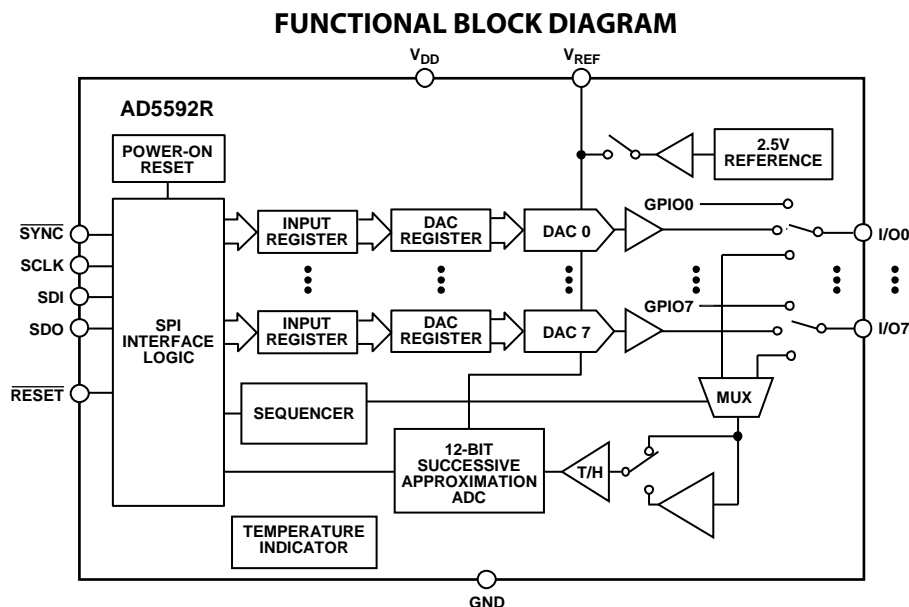


Figure 1. **AD5592R** Functional Block Diagram

Rev. F

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## REVISION HISTORY

### 8/2020—Rev. E to Rev. F

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### 11/2018—Rev. D to Rev. E

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### 8/2017—Rev. C to Rev. D

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### 2/2016—Rev. A to Rev. B

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### 10/2014—Rev. 0 to Rev. A

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### 8/2014—Revision 0: Initial Version

## FUNCTIONAL BLOCK DIAGRAM (AD5592R-1)

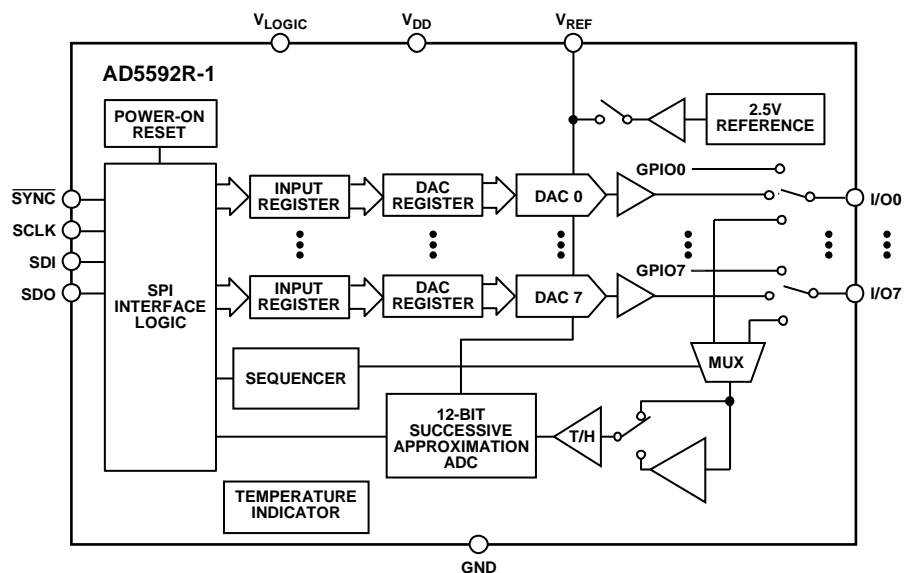


Figure 2. AD5592R-1 Functional Block Diagram

12506-202

## SPECIFICATIONS

$V_{DD} = 2.7\text{ V}$  to  $5.5\text{ V}$ ,  $V_{REF} = 2.5\text{ V}$  (external),  $R_L = 2\text{ k}\Omega$  to GND,  $C_L = 200\text{ pF}$  to GND,  $T_A = T_{MIN}$  to  $T_{MAX}$ , temperature range =  $-40^\circ\text{C}$  to  $+105^\circ\text{C}$ , unless otherwise noted.

Table 2.

| Parameter                                    | Min | Typ         | Max                | Unit <sup>1</sup>            | Test Conditions/Comments  |
|--|-----|-------------|--------------------|------------------------------|---|
| ADC PERFORMANCE                              |     |             |                    |                              |   |
| Resolution                                   |     | 12          |                    | Bits                         | $f_{IN} = 10\text{ kHz}$ sine wave                                      |
| Input Range                                  | 0   |             | $V_{REF}$          | V                            | When using the internal ADC buffer, there is a dead band of 0 V to 5 mV |
|  | 0   |             | $2 \times V_{REF}$ | V                            |   |
| Integral Nonlinearity (INL)                  | -2  |             | +2                 | LSB                          |   |
| Differential Nonlinearity (DNL)              | -1  |             | +1                 | LSB                          |   |
| Offset Error                                 |     |             | $\pm 5$            | mV                           |   |
| Gain Error                                   |     |             | 0.3                | % FSR                        |   |
| Throughput Rate <sup>2</sup>                 |     |             | 400                | kSPS                         |   |
| Track Time ( $t_{TRACK}$ ) <sup>2</sup>      | 500 |             |                    | ns                           |   |
| Conversion Time ( $t_{CONV}$ ) <sup>2</sup>  |     |             | 2                  | $\mu\text{s}$                |   |
| Signal-to-Noise Ratio (SNR)                  |     | 69          |                    | dB                           | $V_{DD} = 2.7\text{ V}$ , input range = 0 V to $V_{REF}$                |
|  |     | 67          |                    | dB                           | $V_{DD} = 5.5\text{ V}$ , input range = 0 V to $V_{REF}$                |
|  |     | 61          |                    | dB                           | $V_{DD} = 5.5\text{ V}$ , input range = 0 V to $2 \times V_{REF}$       |
| Signal-to-Noise-and-Distortion (SINAD) Ratio |     | 69          |                    | dB                           | $V_{DD} = 2.7\text{ V}$ , input range = 0 V to $V_{REF}$                |
|  |     | 67          |                    | dB                           | $V_{DD} = 3.3\text{ V}$ , input range = 0 V to $V_{REF}$                |
|  |     | 60          |                    | dB                           | $V_{DD} = 5.5\text{ V}$ , input range = 0 V to $2 \times V_{REF}$       |
| Total Harmonic Distortion (THD)              |     | -91         |                    | dB                           | $V_{DD} = 2.7\text{ V}$ , input range = 0 V to $V_{REF}$                |
|  |     | -89         |                    | dB                           | $V_{DD} = 3.3\text{ V}$ , input range = 0 V to $V_{REF}$                |
|  |     | -72         |                    | dB                           | $V_{DD} = 5.5\text{ V}$ , input range = 0 V to $2 \times V_{REF}$       |
| Peak Harmonic or Spurious Noise (SFDR)       |     | 91          |                    | dB                           | $V_{DD} = 2.7\text{ V}$ , input range = 0 V to $V_{REF}$                |
|  |     | 91          |                    | dB                           | $V_{DD} = 3.3\text{ V}$ , input range = 0 V to $V_{REF}$                |
|  |     | 72          |                    | dB                           | $V_{DD} = 5.5\text{ V}$ , input range = 0 V to $2 \times V_{REF}$       |
| Aperture Delay <sup>2</sup>                  |     | 15          |                    | ns                           | $V_{DD} = 3\text{ V}$   |
|  |     | 12          |                    | ns                           | $V_{DD} = 5\text{ V}$   |
| Aperture Jitter <sup>2</sup>                 |     | 50          |                    | ps                           |   |
| Channel-to-Channel Isolation                 |     | -95         |                    | dB                           | $f_{IN} = 5\text{ kHz}$   |
| Input Capacitance                            |     | 45          |                    | pF                           |   |
| Full Power Bandwidth                         |     | 8.2         |                    | MHz                          | At 3 dB   |
|  |     | 1.6         |                    | MHz                          | At 0.1 dB   |
| DAC PERFORMANCE <sup>3</sup>                 |     |             |                    |                              |   |
| Resolution                                   |     | 12          |                    | Bits                         |   |
| Output Range                                 | 0   |             | $V_{REF}$          | V                            | Output range = 0 V to $V_{REF}$   |
|  | 0   |             | $2 \times V_{REF}$ | V                            |   |
| Integral Nonlinearity (INL)                  | -1  |             | +1                 | LSB                          |   |
| Differential Nonlinearity (DNL)              | -1  |             | +1                 | LSB                          |   |
| Offset Error                                 | -3  |             | +3                 | mV                           |   |
| Offset Error Drift <sup>2</sup>              |     | 8           |                    | $\mu\text{V}/^\circ\text{C}$ |   |
| Gain Error                                   |     |             | $\pm 0.2$          | % FSR                        | Output range = 0 V to $V_{REF}$   |
|  |     |             | $\pm 0.1$          | % FSR                        |   |
| Zero Code Error                              |     | 0.65        | 2                  | mV                           | Output range = 0 V to $V_{REF}$   |
| Total Unadjusted Error                       |     | $\pm 0.03$  | $\pm 0.25$         | % FSR                        |   |
|  |     | $\pm 0.015$ | $\pm 0.1$          |                              | Output range = 0 V to $2 \times V_{REF}$                                |
| Capacitive Load Stability <sup>2</sup>       |     |             | 2                  | nF                           |   |
|  |     |             | 10                 | nF                           | $R_{LOAD} = \infty$   |
| Resistive Load                               | 1   |             |                    | k $\Omega$                   | $R_{LOAD} = 1\text{ k}\Omega$   |
| Short-Circuit Current                        |     | 25          |                    | mA                           |   |

| Parameter   | Min            | Typ  | Max      | Unit <sup>1</sup> | Test Conditions/Comments  |
|---|----------------|------|----------|-------------------|---|
| DC Crosstalk <sup>2</sup>                           | −4             |      | +4       | μV                | Due to single channel, full-scale output change   |
| DC Output Impedance                                 |                | 0.2  |          | Ω                 |   |
| DC Power Supply Rejection Ratio (PSRR) <sup>2</sup> |                | 0.15 |          | mV/V              | DAC code = midscale, $V_{DD} = 3\text{ V} \pm 10\%$ or $5\text{ V} \pm 10\%$                          |
| Load Impedance at Rails <sup>4</sup>                |                | 25   |          | Ω                 |   |
| Load Regulation                                     |                | 200  |          | μV/mA             | $V_{DD} = 5\text{ V} \pm 10\%$ , DAC code = midscale, $-10\text{ mA} \leq I_{OUT} \leq +10\text{ mA}$ |
|   |                | 200  |          | μV/mA             | $V_{DD} = 3\text{ V} \pm 10\%$ , DAC code = midscale, $-10\text{ mA} \leq I_{OUT} \leq +10\text{ mA}$ |
| Power-Up Time                                       |                | 7    |          | μs                | Coming out of power-down mode, $V_{DD} = 5\text{ V}$  |
| <b>AC SPECIFICATIONS</b>                            |                |      |          |                   |   |
| Slew Rate   |                | 1.25 |          | V/μs              | Measured from 10% to 90% of full scale  |
| Settling Time                                       |                | 6    |          | μs                | ¼ scale to ¾ scale settling to 1 LSB  |
| DAC Glitch Impulse                                  |                | 2    |          | nV-sec            |   |
| DAC to DAC Crosstalk                                |                | 1    |          | nV-sec            |   |
| Digital Crosstalk                                   |                | 0.1  |          | nV-sec            |   |
| Analog Crosstalk                                    |                | 1    |          | nV-sec            |   |
| Digital Feedthrough                                 |                | 0.1  |          | nV-sec            |   |
| Multiplying Bandwidth                               |                | 240  |          | kHz               | DAC code = full scale, output range = 0 V to $V_{REF}$  |
| Output Voltage Noise Spectral Density               |                | 200  |          | nV/√Hz            | DAC code = midscale, output range = 0 V to $2 \times V_{REF}$ , measured at 10 kHz                    |
| Signal-to-Noise Ratio (SNR)                         |                | 81   |          | dB                |   |
| Peak Harmonic or Spurious Noise (SFDR)              |                | 77   |          | dB                |   |
| Signal-to-Noise-and-Distortion (SINAD) Ratio        |                | 74   |          | dB                |   |
| Total Harmonic Distortion (THD)                     |                | −76  |          | dB                |   |
| <b>REFERENCE INPUT</b>                              |                |      |          |                   |   |
| $V_{REF}$ Input Voltage                             | 1              |      | $V_{DD}$ | V                 |   |
| DC Leakage Current                                  | −1             |      | +1       | μA                | No I/O pins configured as DACs  |
| Reference Input Impedance                           |                | 12   |          | kΩ                | DAC output range = 0 V to $2 \times V_{REF}$  |
|   |                | 24   |          | kΩ                | DAC output range = 0 V to $V_{REF}$   |
| <b>REFERENCE OUTPUT</b>                             |                |      |          |                   |   |
| $V_{REF}$ Output Voltage                            | 2.495          | 2.5  | 2.505    | V                 | At ambient  |
| $V_{REF}$ Temperature Coefficient                   |                | 20   |          | ppm/°C            |   |
| Capacitive Load Stability                           |                | 5    |          | μF                | $R_L = 2\text{ k}\Omega$  |
| Output Impedance <sup>2</sup>                       |                | 0.15 |          | Ω                 | $V_{DD} = 2.7\text{ V}$   |
|   |                | 0.7  |          | Ω                 | $V_{DD} = 5\text{ V}$   |
| Output Voltage Noise                                |                | 10   |          | μV p-p            | 0.1 Hz to 10 Hz   |
| Output Voltage Noise Density                        |                | 240  |          | nV/√Hz            | At ambient, $f = 10\text{ kHz}$ , $C_L = 10\text{ nF}$  |
| Line Regulation                                     |                | 20   |          | μV/V              | At ambient, sweeping $V_{DD}$ from 2.7 V to 5.5 V   |
|   |                | 10   |          | μV/V              | At ambient, sweeping $V_{DD}$ from 2.7 V to 3.3 V   |
| Load Regulation                                     |                |      |          |                   |   |
| Sourcing  |                | 210  |          | μV/mA             | At ambient, $-5\text{ mA} \leq \text{load current} \leq +5\text{ mA}$                                 |
| Sinking   |                | 120  |          | μV/mA             | At ambient, $-5\text{ mA} \leq \text{load current} \leq +5\text{ mA}$                                 |
| Output Current Load Capability                      |                | ±5   |          | mA                | $V_{DD} \geq 3\text{ V}$  |
| <b>GPIO OUTPUT</b>                                  |                |      |          |                   |   |
| $I_{SOURCE}$ , $I_{SINK}$                           |                | 1.6  |          | mA                |   |
| Output Voltage                                      |                |      |          |                   |   |
| High ( $V_{OH}$ )                                   | $V_{DD} - 0.2$ |      |          | V                 | $I_{SOURCE} = 1\text{ mA}$  |
| Low ( $V_{OL}$ )                                    |                |      | 0.4      | V                 | $I_{SOURCE} = 1\text{ mA}$  |

| Parameter                             | Min                    | Typ     | Max                    | Unit <sup>1</sup> | Test Conditions/Comments  |
|---------------------------------------|------------------------|---------|------------------------|-------------------|---|
| <b>GPIO INPUT</b>                     |                        |         |                        |                   |   |
| Input Voltage                         |                        |         |                        |                   |   |
| High ( $V_{IH}$ )                     | $0.7 \times V_{DD}$    |         |                        | V                 |   |
| Low ( $V_{IL}$ )                      |                        |         | $0.3 \times V_{DD}$    | V                 |   |
| Input Capacitance                     |                        | 20      |                        | pF                |   |
| Hysteresis                            |                        | 0.2     |                        | V                 |   |
| Input Current                         |                        | $\pm 1$ |                        | $\mu A$           |   |
| <b>LOGIC INPUTS</b>                   |                        |         |                        |                   |   |
| AD5592R Input Voltage                 |                        |         |                        |                   |   |
| High ( $V_{INH}$ )                    | $0.7 \times V_{DD}$    |         |                        | V                 |   |
| Low ( $V_{INL}$ )                     |                        |         | $0.3 \times V_{DD}$    | V                 |   |
| AD5592R-1 Input Voltage               |                        |         |                        |                   |   |
| High ( $V_{INH}$ )                    | $0.7 \times V_{LOGIC}$ |         |                        | V                 |   |
| Low ( $V_{INL}$ )                     |                        |         | $0.3 \times V_{LOGIC}$ | V                 |   |
| Input Current ( $I_{IN}$ )            | -1                     |         | +1                     | $\mu A$           | Typically 10 nA, $\overline{RESET} = 1 \mu A$ typical   |
| Input Capacitance ( $C_{IN}$ )        |                        |         | 10                     | pF                |   |
| <b>LOGIC OUTPUT (SDO)</b>             |                        |         |                        |                   |   |
| Output High Voltage ( $V_{OH}$ )      | $V_{DD} - 0.2$         |         |                        | V                 | $I_{SOURCE} = 200 \mu A$ , $V_{DD} = 2.7 V$ to 5.5 V  |
| AD5592R                               | $V_{LOGIC} - 0.2$      |         |                        | V                 | $I_{SOURCE} = 200 \mu A$ , $V_{DD} = 2.7 V$ to 5.5 V  |
| AD5592R-1                             |                        |         |                        |                   |   |
| Output Low Voltage ( $V_{OL}$ )       |                        |         | 0.4                    | V                 | $I_{SINK} = 200 \mu A$  |
| Floating-State Output Capacitance     |                        | 10      |                        | pF                |   |
| <b>TEMPERATURE SENSOR<sup>2</sup></b> |                        |         |                        |                   |   |
| Resolution                            |                        | 12      |                        | Bits              |   |
| Operating Range                       | -40                    |         | +105                   | $^{\circ}C$       |   |
| Accuracy                              |                        | $\pm 3$ |                        | $^{\circ}C$       | 5 sample averaging  |
| Track Time                            |                        |         | 5                      | $\mu s$           | ADC buffer enabled  |
|                                       |                        |         | 20                     | $\mu s$           | ADC buffer disabled   |
| <b>POWER REQUIREMENTS</b>             |                        |         |                        |                   |   |
| $V_{DD}$                              | 2.7                    |         | 5.5                    | V                 |   |
| $I_{DD}$                              |                        |         | 2.7                    | mA                | Digital inputs = 0 V or $V_{DD}$ , I/O0 to I/O7 configured as DACs and ADCs, internal reference on, ADC buffer on, DAC code = 0xFFF, range is 0 V to $2 \times V_{REF}$ for DACs and ADCs |
| Power-Down Mode                       |                        |         | 3.5                    | $\mu A$           |   |
| $V_{DD} = 5 V$ (Normal Mode)          |                        | 1.6     |                        | mA                | I/O0 to I/O7 are DACs, internal reference, gain = 2   |
|                                       |                        | 1       |                        | mA                | I/O0 to I/O7 are DACs, external reference, gain = 2   |
|                                       |                        | 2.4     |                        | mA                | I/O0 to I/O7 are DACs and sampled by the ADC, internal reference, gain = 2  |
|                                       |                        | 1.1     |                        | mA                | I/O0 to I/O7 are DACs and sampled by the ADC, external reference, gain = 2  |
|                                       |                        | 1       |                        | mA                | I/O0 to I/O7 are ADCs, internal reference, gain = 2   |
|                                       |                        | 0.75    |                        | mA                | I/O0 to I/O7 are ADCs, external reference, gain = 2   |
|                                       |                        | 0.5     |                        | mA                | I/O0 to I/O7 are general-purpose outputs  |
|                                       |                        | 0.5     |                        | mA                | I/O0 to I/O7 are general-purpose inputs   |
|                                       |                        | 0.5     |                        | mA                | I/O0 to I/O3 are general-purpose outputs, I/O4 to I/O7 are general-purpose inputs   |

| Parameter                           | Min  | Typ  | Max      | Unit <sup>1</sup> | Test Conditions/Comments   |
|-------------------------------------|------|------|----------|-------------------|--|
| $V_{DD} = 3\text{ V}$ (Normal Mode) |      | 1.1  |          | mA                | I/O0 to I/O7 are DACs, internal reference, gain = 1                        |
|                                     |      | 1    |          | mA                | I/O0 to I/O7 are DACs, external reference, gain = 1                        |
|                                     |      | 1.1  |          | mA                | I/O0 to I/O7 are DACs and sampled by the ADC, internal reference, gain = 1 |
|                                     |      | 0.78 |          | mA                | I/O0 to I/O7 are DACs and sampled by the ADC, external reference, gain = 1 |
|                                     |      | 0.75 |          | mA                | I/O0 to I/O7 are ADCs, internal reference, gain = 1                        |
|                                     |      | 0.5  |          | mA                | I/O0 to I/O7 are ADCs, external reference, gain = 1                        |
|                                     |      | 0.45 |          | mA                | I/O0 to I/O7 are general-purpose outputs                                   |
|                                     |      | 0.45 |          | mA                | I/O0 to I/O7 are general-purpose inputs                                    |
| $V_{LOGIC}$                         | 1.62 |      | $V_{DD}$ | V                 | AD5592R-1 only   |
| $I_{LOGIC}$                         |      |      | 3        | $\mu\text{A}$     | AD5592R-1 only   |

<sup>1</sup> All specifications expressed in decibels are referred to full-scale input (FSR) and tested with an input signal at 0.5 dB below full scale, unless otherwise noted.

<sup>2</sup> Guaranteed by design and characterization; not production tested.

<sup>3</sup> DC specifications tested with the outputs unloaded, unless otherwise noted. Linearity calculated using a code range of 8 to 4095. There is an upper dead band of 10 mV when  $V_{REF} = V_{DD}$ .

<sup>4</sup> When drawing a load current at either rail, the output voltage headroom with respect to that rail is limited by the 25  $\Omega$  typical channel resistance of the output devices. For example, when sinking 1 mA, the minimum output voltage = 25  $\Omega \times 1\text{ mA} = 25\text{ mV}$  (see Figure 33).

## TIMING CHARACTERISTICS

Guaranteed by design and characterization, not production tested; all input signals are specified with  $t_R = t_F = 5\text{ ns}$  (10% to 90% of  $V_{DD}$ ) and timed from a voltage level of  $(V_{IL} + V_{IH})/2$ ;  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

Table 3. AD5592R Timing Characteristics

| Parameter | $2.7\text{ V} \leq V_{DD} < 3\text{ V}$ | $3\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ | Unit              | Test Conditions/Comments   |
|-----------|---|--|-------------------|--|
| $t_1$     | 33                                      | 20   | ns min            | SCLK cycle time, write operation   |
|           | 50                                      | 50   | ns min            | SCLK cycle time, read operation  |
| $t_2$     | 16                                      | 10   | ns min            | SCLK high time   |
| $t_3$     | 16                                      | 10   | ns min            | SCLK low time  |
| $t_4$     | 15                                      | 10   | ns min            | $\overline{\text{SYNC}}$ falling edge to SCLK falling edge setup time              |
|           | 2                                       | 2  | $\mu\text{s}$ max | $\overline{\text{SYNC}}$ falling edge to SCLK falling edge setup time <sup>1</sup> |
| $t_5$     | 7                                       | 7  | ns min            | Data setup time  |
| $t_6$     | 5                                       | 5  | ns min            | Data hold time   |
| $t_7$     | 15                                      | 10   | ns min            | SCLK falling edge to $\overline{\text{SYNC}}$ rising edge                          |
| $t_8$     | 30                                      | 30   | ns min            | Minimum $\overline{\text{SYNC}}$ high time for register write operations           |
|           | 60                                      | 60   | ns min            | Minimum $\overline{\text{SYNC}}$ high time for register read operations            |
| $t_9$     | 0                                       | 0  | ns min            | $\overline{\text{SYNC}}$ rising edge to next SCLK falling edge                     |
| $t_{10}$  | 25                                      | 25   | ns max            | SCLK rising edge to SDO valid  |
| $t_{11}$  | 250                                     | 250  | ns min            | $\overline{\text{RESET}}$ low pulse width (not shown in Figure 4)                  |

<sup>1</sup> When reading an ADC conversion.

Table 4. AD5592R-1 Timing Characteristics

| Parameter | $1.62\text{ V} \leq V_{\text{LOGIC}} < 3\text{ V}$ | $3\text{ V} \leq V_{\text{LOGIC}} \leq 5.5\text{ V}$ | Unit              | Test Conditions/Comments  |
|-----------|--|--|-------------------|---|
| $t_1$     | 33   | 20   | ns min            | SCLK cycle time, write operation  |
|           | 65   | 50   | ns min            | SCLK cycle time, read operation   |
| $t_2$     | 16   | 10   | ns min            | SCLK high time  |
| $t_3$     | 16   | 10   | ns min            | SCLK low time   |
| $t_4$     | 15   | 10   | ns min            | $\overline{\text{SYNC}}$ to SCLK falling edge setup time                |
|           | 2  | 2  | $\mu\text{s max}$ | $\overline{\text{SYNC}}$ to SCLK falling edge setup time                |
| $t_5$     | 7  | 7  | ns min            | Data setup time   |
| $t_6$     | 5  | 5  | ns min            | Data hold time  |
| $t_7$     | 15   | 10   | ns min            | SCLK falling edge to $\overline{\text{SYNC}}$ rising edge               |
| $t_8$     | 30   | 30   | ns min            | Minimum $\overline{\text{SYNC}}$ high time for write operations         |
|           | 60   | 60   | ns min            | Minimum $\overline{\text{SYNC}}$ high time for register read operations |
| $t_9$     | 0  | 0  | ns min            | $\overline{\text{SYNC}}$ rising edge to next SCLK falling edge          |
| $t_{10}$  | 56   | 25   | ns max            | SCLK rising edge to SDO valid   |

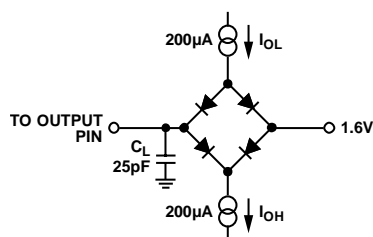


Figure 3. Load Circuit for Logic Output (SDO) Timing Specifications

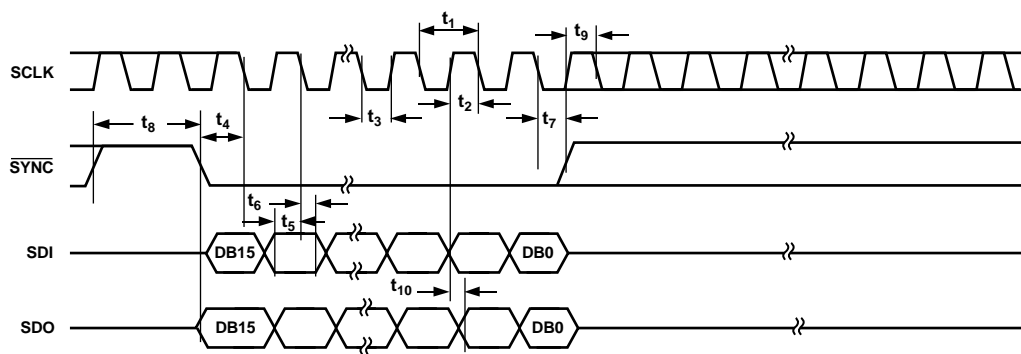


Figure 4. Timing Diagram



## ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$ , unless otherwise noted. Transient currents of up to 100 mA do not cause SCR latch-up.

Table 5.

| Parameter                         | Rating                                      |
|-----------------------------------|---|
| $V_{DD}$ to GND                   | $-0.3\text{ V to }+7\text{ V}$              |
| $V_{LOGIC}$ to GND                | $-0.3\text{ V to }+7\text{ V}$              |
| Analog Input Voltage to GND       | $-0.3\text{ V to }V_{DD} + 0.3\text{ V}$    |
| AD5592R                           |   |
| Digital Input Voltage to GND      | $-0.3\text{ V to }V_{DD} + 0.3\text{ V}$    |
| Digital Output Voltage to GND     | $-0.3\text{ V to }V_{DD} + 0.3\text{ V}$    |
| AD5592R-1                         |   |
| Digital Input Voltage to GND      | $-0.3\text{ V to }V_{LOGIC} + 0.3\text{ V}$ |
| Digital Output Voltage to GND     | $-0.3\text{ V to }V_{LOGIC} + 0.3\text{ V}$ |
| $V_{REF}$ to GND                  | $-0.3\text{ V to }V_{DD} + 0.3\text{ V}$    |
| Operating Temperature Range       | $-40^\circ\text{C to }+105^\circ\text{C}$   |
| Storage Temperature Range         | $-65^\circ\text{C to }+150^\circ\text{C}$   |
| Junction Temperature ( $T_J$ max) | $150^\circ\text{C}$                         |
| Lead Temperature                  | JEDEC industry standard                     |
| Soldering                         | J-STD-020                                   |

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## THERMAL RESISTANCE

$\theta_{JA}$  is specified for the worst-case conditions, that is, a device soldered in a circuit board for surface-mount packages.

Table 6. Thermal Resistance

| Package Type  | $\theta_{JA}$ | Unit               |
|---------------|---------------|--------------------|
| 16-Ball WLCSP | 60            | $^\circ\text{C/W}$ |
| 16-Lead LFCSP | 137           | $^\circ\text{C/W}$ |
| 16-Lead TSSOP | 112           | $^\circ\text{C/W}$ |

## ESD CAUTION



### ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

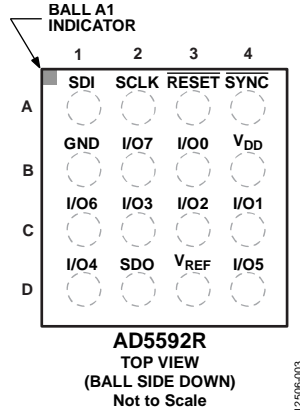


Figure 5. AD5592R 16-Ball WLCSP Pin Configuration

Table 7. AD5592R 16-Ball WLCSP Pin Function Descriptions

| Pin No.                    | Mnemonic     | Description  |
|----------------------------|--------------|--|
| A1                         | SDI          | Data In. Logic input. Data that is to be written to the DACs and control registers is provided on this input and is clocked into the register on the falling edge of SCLK.   |
| A2                         | SCLK         | Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at rates of up to 50 MHz when writing to the DACs. SCLK has a maximum speed of 20 MHz when performing a conversion or clocking data from the AD5592R.   |
| A3                         | RESET        | Asynchronous Reset Pin. Tie this pin high for normal operation. When this pin is brought low, the AD5592R is reset to its default configuration.   |
| A4                         | SYNC         | Synchronization. Active low control input. SYNC is the frame synchronization signal for the input data. When SYNC goes low, data is transferred in on the falling edges of the next 16 clocks.   |
| B1                         | GND          | Ground Reference Point for All Circuitry on the AD5592R.   |
| B2                         | I/O7         | Input/Output 7. This pin can be configured as a DAC, ADC, or general-purpose digital input or output. The function of this pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16). I/O7 can also be configured as a BUSY signal to indicate when an ADC conversion is taking place (see Table 30 and Table 31).   |
| B3, C4, C3, C2, D1, D4, C1 | I/O0 to I/O6 | Input/Output 0 Through Input/Output 6. These pins can be independently configured as DACs, ADCs, or general-purpose digital inputs or outputs. The function of each pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16).   |
| B4                         | VDD          | Power Supply Input. The AD5592R operates from 2.7 V to 5.5 V, and this pin must be decoupled with a 0.1 $\mu$ F capacitor to GND.  |
| D2                         | SDO          | Data Out. Logic output. The conversion results from the ADC, register reads, and temperature sensor information are provided on this output as a serial data stream. The bits are clocked out on the rising edge of the SCLK input. The MSB is placed on the SDO pin on the falling edge of SYNC. Because the SCLK can idle high or low, the next bit is clocked out on the first rising edge of SCLK that follows a falling edge SCLK while SYNC is low (see Figure 4). |
| D3                         | VREF         | Reference Input/Output. When the internal reference is enabled, the 2.5 V reference voltage is available on this pin. A 0.1 $\mu$ F capacitor connected from the VREF pin to GND is recommended to achieve the specified performance from the AD5592R. When the internal reference is disabled, an external reference must be applied to this pin. The voltage range for the external reference is 1 V to VDD.   |

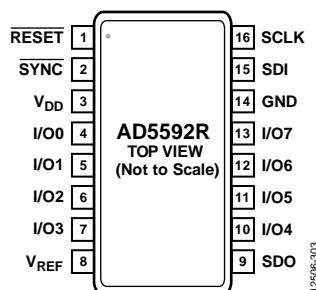


Figure 6. AD5592R 16-Lead TSSOP Pin Configuration

Table 8. AD5592R 16-Lead TSSOP Pin Function Descriptions

| Pin No.                | Mnemonic     | Description  |
|------------------------|--------------|--|
| 15                     | SDI          | Data In. Logic input. Data that is to be written to the DACs and control registers is provided on this input and is clocked into the register on the falling edge of SCLK.   |
| 16                     | SCLK         | Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at rates of up to 50 MHz when writing to the DACs. SCLK has a maximum speed of 20 MHz when performing a conversion or clocking data from the AD5592R.   |
| 1                      | RESET        | Asynchronous Reset Pin. Tie this pin high for normal operation. When this pin is brought low, the AD5592R is reset to its default configuration.   |
| 2                      | SYNC         | Synchronization. Active low control input. SYNC is the frame synchronization signal for the input data. When SYNC goes low, data is transferred in on the falling edges of the next 16 clocks.   |
| 14                     | GND          | Ground Reference Point for All Circuitry on the AD5592R.   |
| 13                     | I/O7         | Input/Output 7. This pin can be configured as a DAC, ADC, or general-purpose digital input or output. The function of this pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16). I/O7 can also be configured as a BUSY signal to indicate when an ADC conversion is taking place (see Table 30 and Table 31).   |
| 4, 5, 6, 7, 10, 11, 12 | I/O0 to I/O6 | Input/Output 0 Through Input/Output 6. These pins can be independently configured as DACs, ADCs, or general-purpose digital inputs or outputs. The function of each pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16).   |
| 3                      | VDD          | Power Supply Input. The AD5592R operates from 2.7 V to 5.5 V, and this pin must be decoupled with a 0.1 $\mu$ F capacitor to GND.  |
| 9                      | SDO          | Data Out. Logic output. The conversion results from the ADC, register reads, and temperature sensor information are provided on this output as a serial data stream. The bits are clocked out on the rising edge of the SCLK input. The MSB is placed on the SDO pin on the falling edge of SYNC. Because the SCLK can idle high or low, the next bit is clocked out on the first rising edge of SCLK that follows a falling edge SCLK while SYNC is low (see Figure 4). |
| 8                      | VREF         | Reference Input/Output. When the internal reference is enabled, the 2.5 V reference voltage is available on this pin. A 0.1 $\mu$ F capacitor connected from the VREF pin to GND is recommended to achieve the specified performance from the AD5592R. When the internal reference is disabled, an external reference must be applied to this pin. The voltage range for the external reference is 1 V to VDD.   |

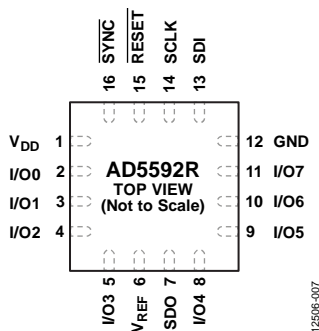


Figure 7. AD5592R 16-Lead LFCSP Pin Configuration

Table 9. AD5592R 16-Lead LFCSP Pin Function Descriptions

| Pin No.              | Mnemonic         | Description  |
|----------------------|------------------|--|
| 1                    | V <sub>DD</sub>  | Power Supply Input. The AD5592R operates from 2.7 V to 5.5 V, and this pin must be decoupled with a 0.1 $\mu$ F capacitor to GND.  |
| 2, 3, 4, 5, 8, 9, 10 | I/O0 to I/O6     | Input/Output 0 Through Input/Output 6. These pins can be independently configured as DACs, ADCs, or general-purpose digital inputs or outputs. The function of each pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16).   |
| 6                    | V <sub>REF</sub> | Reference Input/Output. When the internal reference is enabled, the 2.5 V reference voltage is available on this pin. A 0.1 $\mu$ F capacitor connected from the V <sub>REF</sub> pin to GND is recommended to achieve the specified performance from the AD5592R. When the internal reference is disabled, an external reference must be applied to this pin. The voltage range for the external reference is 1 V to V <sub>DD</sub> .                                  |
| 7                    | SDO              | Data Out. Logic output. The conversion results from the ADC, register reads, and temperature sensor information are provided on this output as a serial data stream. The bits are clocked out on the rising edge of the SCLK input. The MSB is placed on the SDO pin on the falling edge of SYNC. Because the SCLK can idle high or low, the next bit is clocked out on the first rising edge of SCLK that follows a falling edge SCLK while SYNC is low (see Figure 4). |
| 11                   | I/O7             | Input/Output 7. This pin can be configured as a DAC, ADC, or general-purpose digital input or output. The function of this pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16). I/O7 can also be configured as a BUSY signal to indicate when an ADC conversion is taking place (see Table 30 and Table 31).   |
| 12                   | GND              | Ground Reference Point for All Circuitry on the AD5592R.   |
| 13                   | SDI              | Data In. Logic input. Data that is to be written to the DACs and control registers is provided on this input and is clocked into the register on the falling edge of SCLK.   |
| 14                   | SCLK             | Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at rates of up to 50 MHz when writing to the DACs. SCLK has a maximum speed of 20 MHz when performing a conversion or clocking data from the AD5592R.   |
| 15                   | RESET            | Asynchronous Reset Pin. Tie this pin high for normal operation. When this pin is brought low, the AD5592R is reset to its default configuration.   |
| 16                   | SYNC             | Synchronization. Active low control input. SYNC is the frame synchronization signal for the input data. When SYNC goes low, data is transferred in on the falling edges of the next 16 clocks.   |

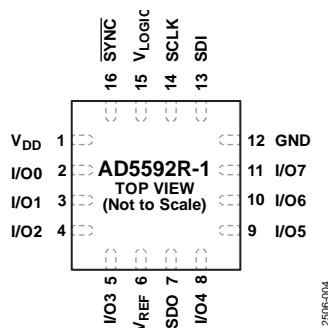


Figure 8. AD5592R-1 16-Lead LFCSP Pin Configuration

Table 10. AD5592R-1 16-Lead LFCSP Pin Function Descriptions

| Pin No.         | Mnemonic           | Description  |
|-----------------|--------------------|--|
| 1               | V <sub>DD</sub>    | Power Supply Input. The AD5592R-1 operates from 2.7 V to 5.5 V, and this pin must be decoupled with a 0.1 $\mu$ F capacitor to GND.  |
| 2 to 5, 8 to 10 | I/O0 to I/O6       | Input/Output 0 Through Input/Output 6. These pins can be independently configured as DACs, ADCs, or general-purpose digital inputs or outputs. The function of each pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16).   |
| 6               | V <sub>REF</sub>   | Reference Input/Output. When the internal reference is enabled, the 2.5 V reference voltage is available on this pin. A 0.1 $\mu$ F capacitor connected from the V <sub>REF</sub> pin to GND is recommended to achieve the specified performance from the AD5592R-1. When the internal reference is disabled, an external reference must be applied to this pin. The voltage range for the external reference is 1 V to V <sub>DD</sub> .                                |
| 7               | SDO                | Data Out. Logic output. The conversion results from the ADC, register reads, and temperature sensor information are provided on this output as a serial data stream. The bits are clocked out on the rising edge of the SCLK input. The MSB is placed on the SDO pin on the falling edge of SYNC. Because the SCLK can idle high or low, the next bit is clocked out on the first rising edge of SCLK that follows a falling edge SCLK while SYNC is low (see Figure 4). |
| 11              | I/O7               | Input/Output 7. This pin can be configured as a DAC, ADC, or general-purpose digital input or output. The function of this pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16). I/O7 can also be configured as a BUSY signal to indicate when an ADC conversion is taking place (see Table 30 and Table 31).   |
| 12              | GND                | Ground Reference Point for All Circuitry on the AD5592R-1.   |
| 13              | SDI                | Data In. Logic input. Data to be written to the DACs and control registers is provided on this input and is clocked into the register on the falling edge of SCLK.   |
| 14              | SCLK               | Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at rates of up to 50 MHz when writing to the DACs. SCLK has a maximum speed of 20 MHz when performing a conversion or clocking data from the AD5592R-1.   |
| 15              | V <sub>LOGIC</sub> | Interface Power Supply. The voltage of this pin ranges from 1.62 V to 5.5 V.   |
| 16              | SYNC               | Synchronization. Active low control input. SYNC is the frame synchronization signal for the input data. When SYNC goes low, data is transferred in on the falling edges of the next 16 clocks.   |

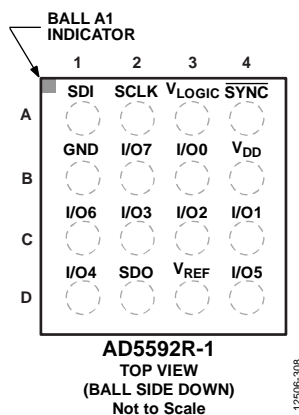
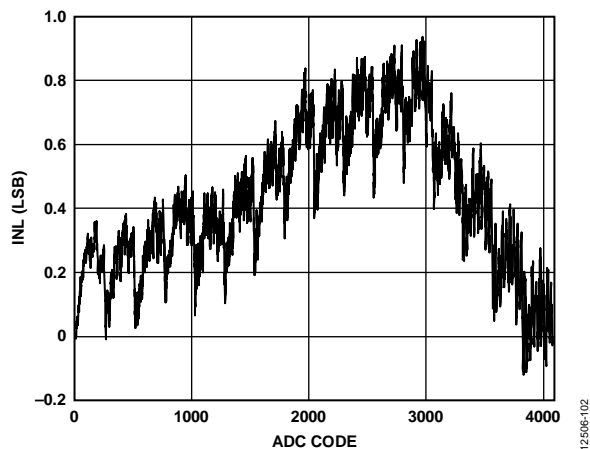
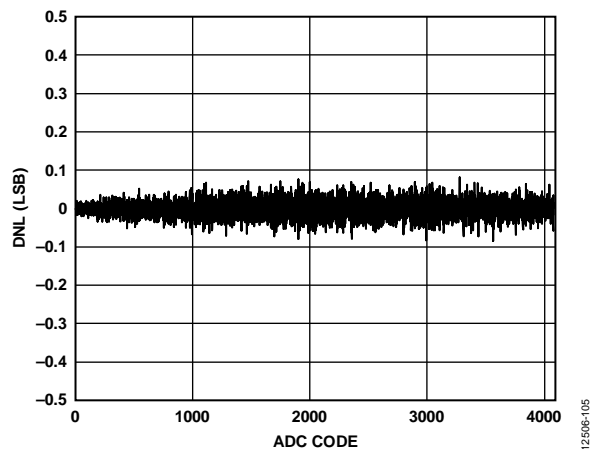
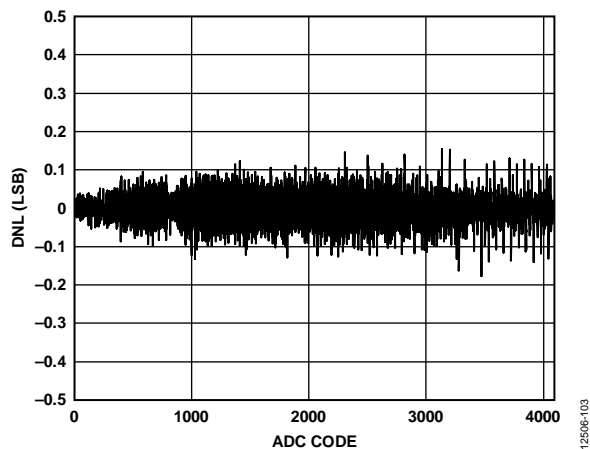
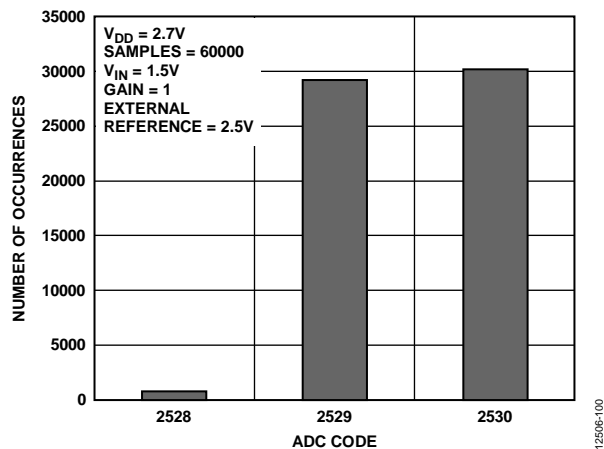
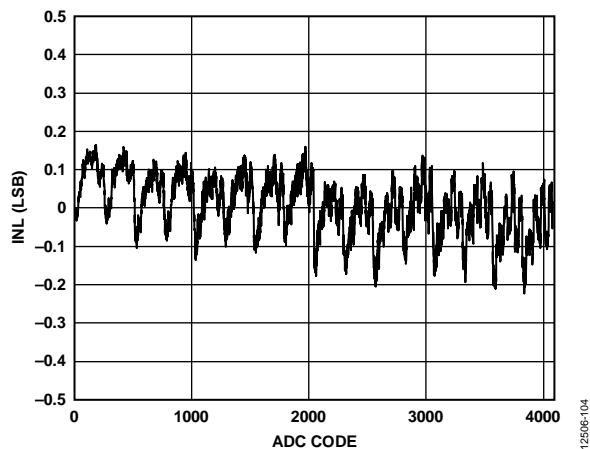
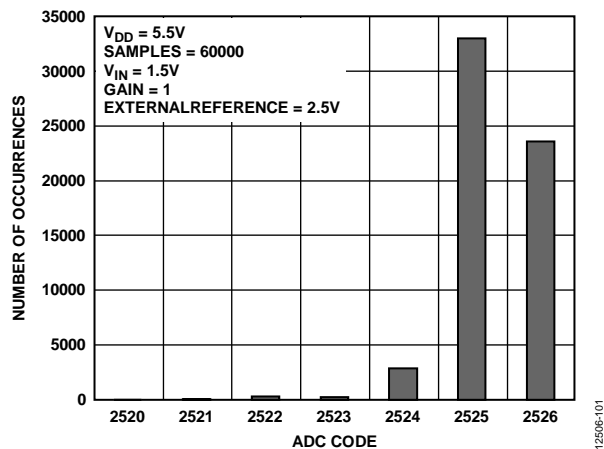


Figure 9. AD5592R-1 16-Ball WLCSP Pin Configuration

Table 11. AD5592R-1 16-Lead WLCSP Pin Function Descriptions

| Pin No.                    | Mnemonic           | Description  |
|----------------------------|--------------------|--|
| B4                         | V <sub>DD</sub>    | Power Supply Input. The AD5592R-1 operates from 2.7 V to 5.5 V, and this pin must be decoupled with a 0.1 $\mu$ F capacitor to GND.  |
| B3, C4, C3, C2, D1, D4, C1 | I/O0 to I/O6       | Input/Output 0 Through Input/Output 6. These pins can be independently configured as DACs, ADCs, or general-purpose digital inputs or outputs. The function of each pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16).   |
| D3                         | V <sub>REF</sub>   | Reference Input/Output. When the internal reference is enabled, the 2.5 V reference voltage is available on this pin. A 0.1 $\mu$ F capacitor connected from the V <sub>REF</sub> pin to GND is recommended to achieve the specified performance from the AD5592R-1. When the internal reference is disabled, an external reference must be applied to this pin. The voltage range for the external reference is 1 V to V <sub>DD</sub> .                                |
| D2                         | SDO                | Data Out. Logic output. The conversion results from the ADC, register reads, and temperature sensor information are provided on this output as a serial data stream. The bits are clocked out on the rising edge of the SCLK input. The MSB is placed on the SDO pin on the falling edge of SYNC. Because the SCLK can idle high or low, the next bit is clocked out on the first rising edge of SCLK that follows a falling edge SCLK while SYNC is low (see Figure 4). |
| B2                         | I/O7               | Input/Output 7. This pin can be configured as a DAC, ADC, or general-purpose digital input or output. The function of this pin is determined by programming the I/Ox pin configuration registers (see Table 15 and Table 16). I/O7 can also be configured as a BUSY signal to indicate when an ADC conversion is taking place (see Table 30 and Table 31).   |
| B1                         | GND                | Ground Reference Point for All Circuitry on the AD5592R-1.   |
| A1                         | SDI                | Data In. Logic input. Data to be written to the DACs and control registers is provided on this input and is clocked into the register on the falling edge of SCLK.   |
| A2                         | SCLK               | Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at rates of up to 50 MHz when writing to the DACs. SCLK has a maximum speed of 20 MHz when performing a conversion or clocking data from the AD5592R-1.   |
| A3                         | V <sub>LOGIC</sub> | Interface Power Supply. The voltage of this pin ranges from 1.62 V to 5.5 V.   |
| A4                         | SYNC               | Synchronization. Active low control input. SYNC is the frame synchronization signal for the input data. When SYNC goes low, data is transferred in on the falling edges of the next 16 clocks.   |

## TYPICAL PERFORMANCE CHARACTERISTICS

Figure 10. ADC INL,  $V_{DD} = 5.5\text{ V}$ Figure 13. ADC DNL,  $V_{DD} = 2.7\text{ V}$ Figure 11. ADC DNL,  $V_{DD} = 5.5\text{ V}$ Figure 14. Histogram of ADC Codes,  $V_{DD} = 2.7\text{ V}$ Figure 12. ADC INL,  $V_{DD} = 2.7\text{ V}$ Figure 15. Histogram of ADC Codes,  $V_{DD} = 5.5\text{ V}$

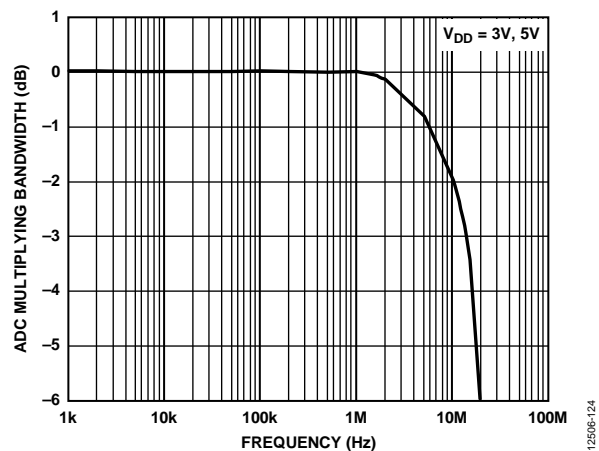


Figure 16. ADC Multiplying Bandwidth

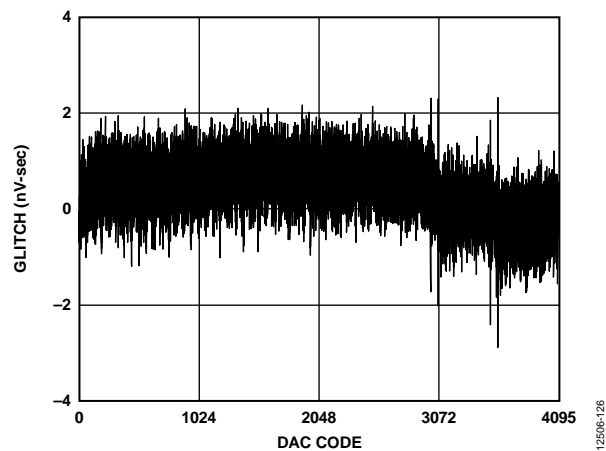


Figure 19. DAC Adjacent Code Glitch

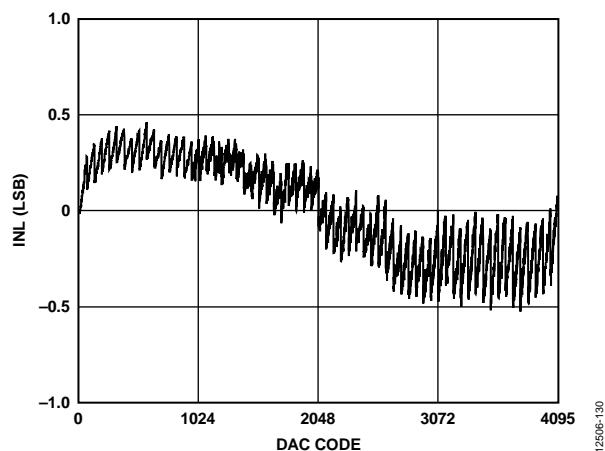


Figure 17. DAC INL

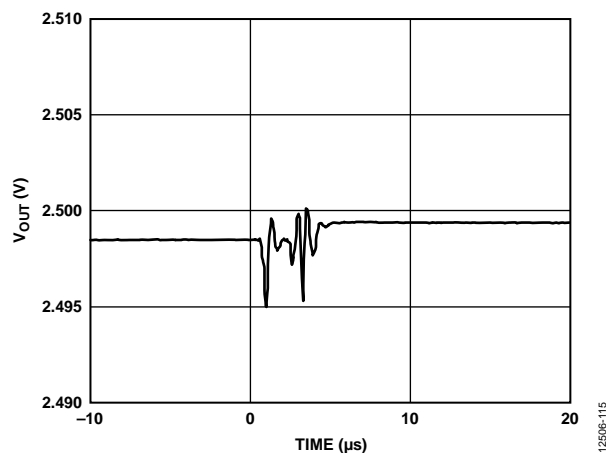


Figure 20. DAC Digital-to-Analog Glitch (Rising)

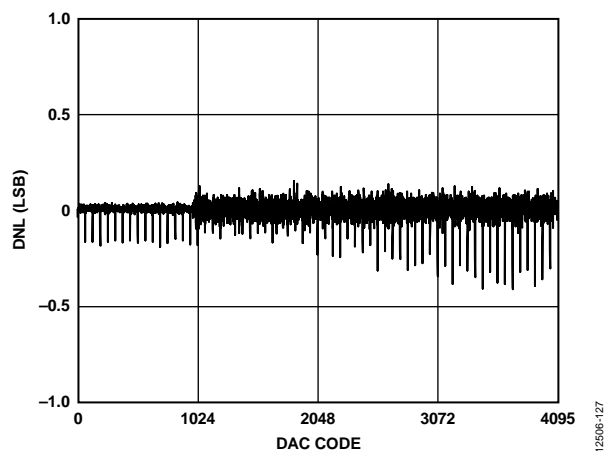


Figure 18. DAC DNL

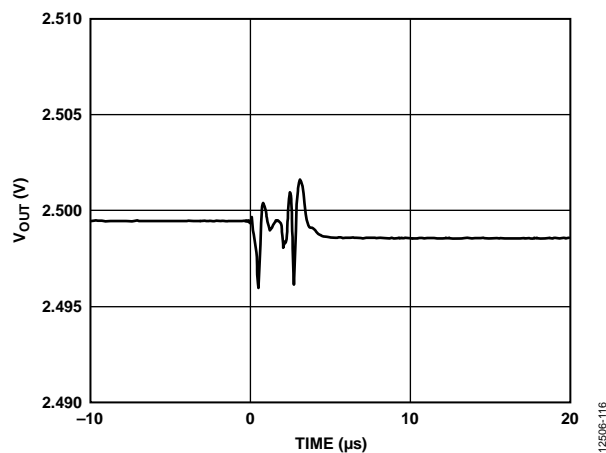


Figure 21. DAC Digital-to-Analog Glitch (Falling)



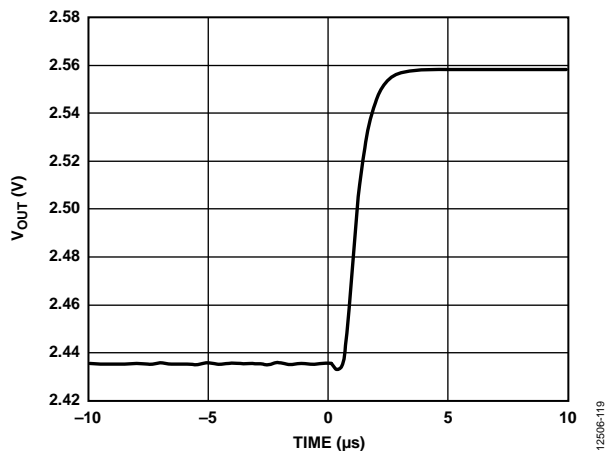


Figure 22. DAC Settling Time (100 Code Change, Rising Edge)

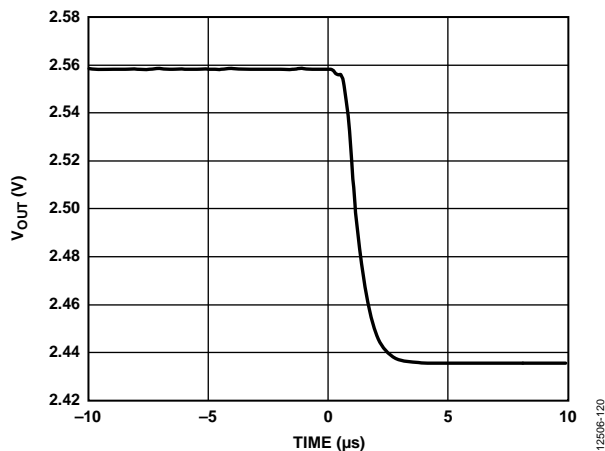


Figure 23. DAC Settling Time (100 Code Change, Falling Edge)

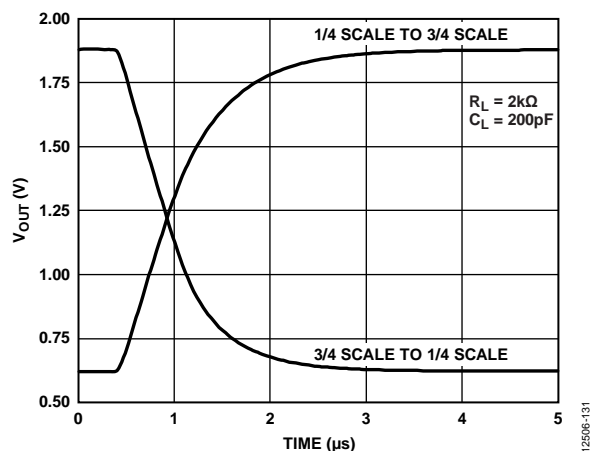
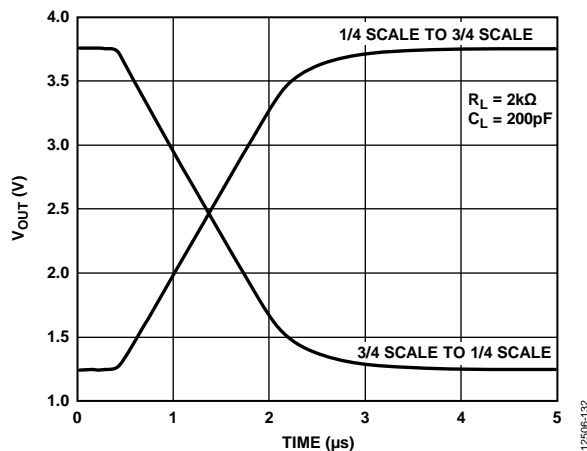
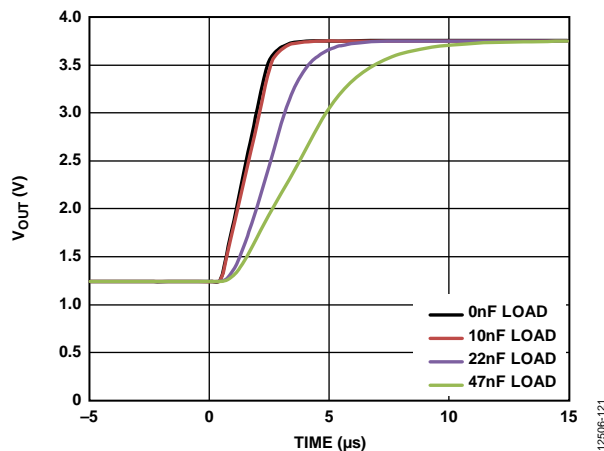
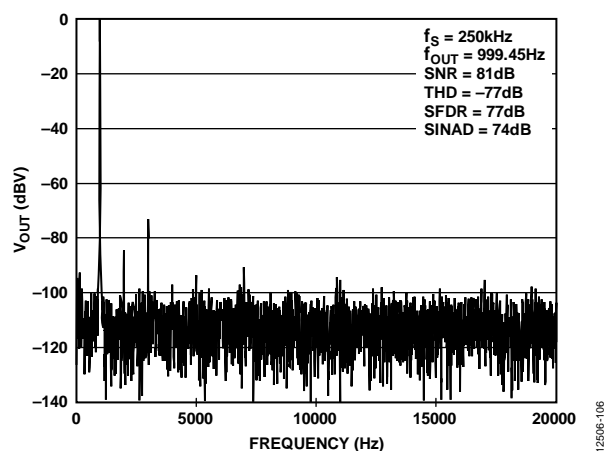
Figure 24. DAC Settling Time, Output Range = 0 V to  $V_{REF}$ Figure 25. DAC Settling Time, Output Range = 0 V to  $2 \times V_{REF}$ 

Figure 26. DAC Settling Time for Various Capacitive Loads

Figure 27. DAC Sine Wave Output, Output Range = 0 V to  $2 \times V_{REF}$   
Bandwidth = 0 Hz to 20 kHz

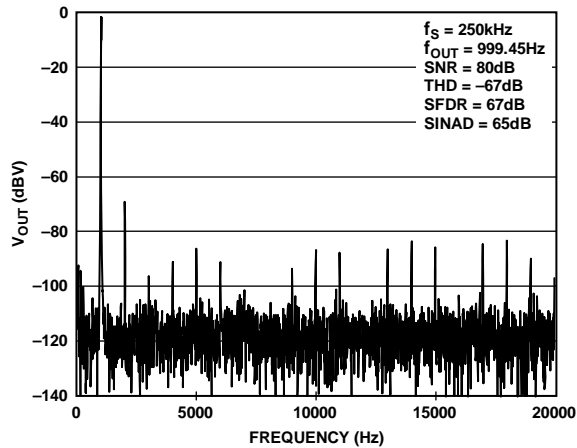


Figure 28. DAC Sine Wave Output, Output Range = 0 V to  $V_{REF}$ , Bandwidth = 0 Hz to 20 kHz

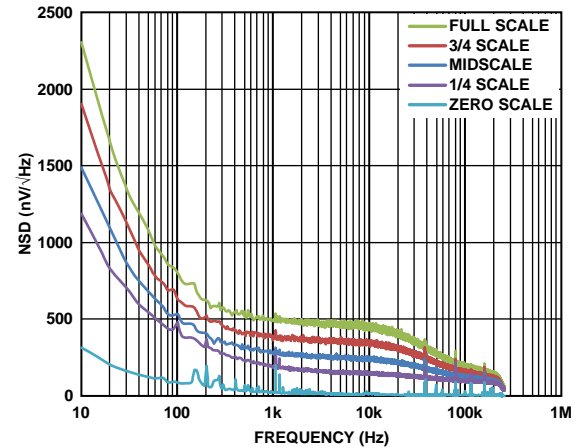


Figure 31. DAC Output Noise Spectral Density (NSD)

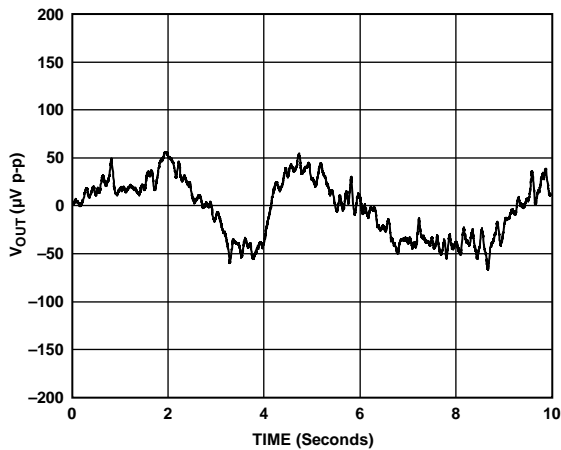


Figure 29. DAC 1/f Noise with External Reference

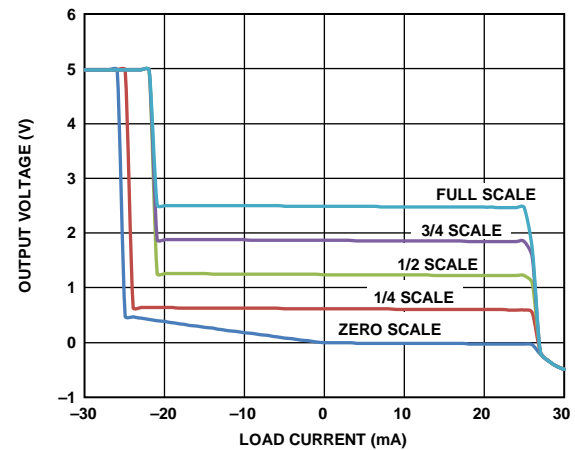


Figure 32. DAC Output Sink and Source Capability, Output Range = 0 V to  $V_{REF}$

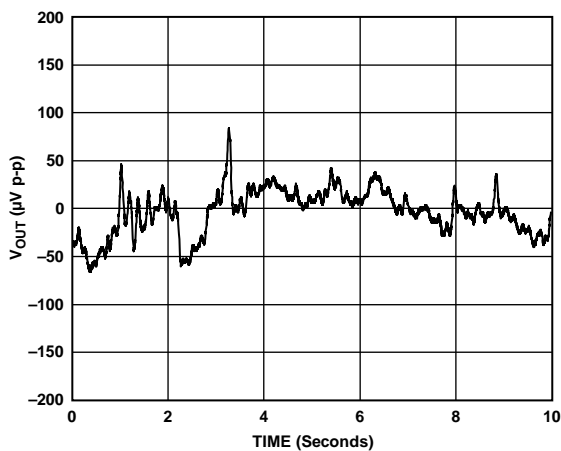


Figure 30. DAC 1/f Noise with Internal Reference

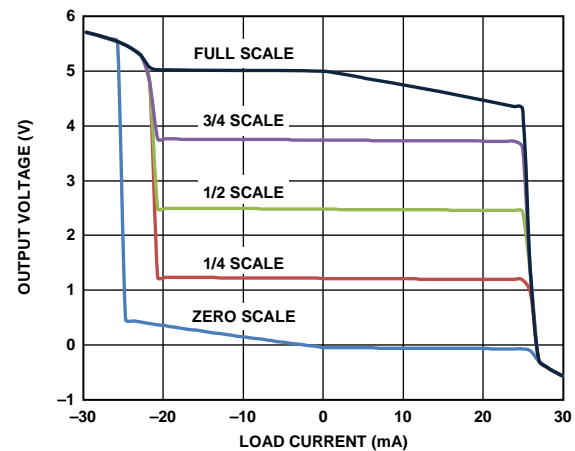


Figure 33. DAC Output Sink and Source Capability, Output Range = 0 V to  $2 \times V_{REF}$

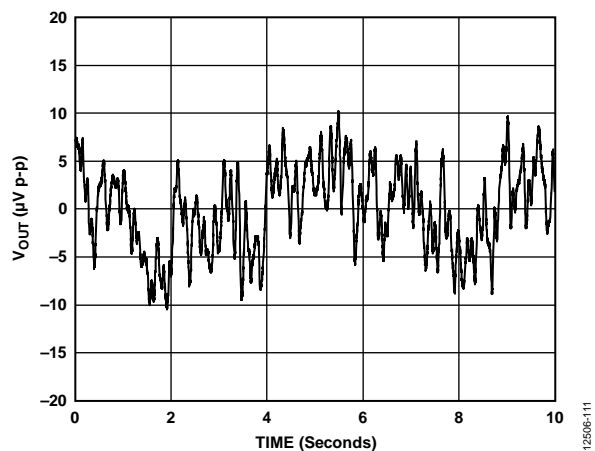


Figure 34. Internal Reference 1/f Noise

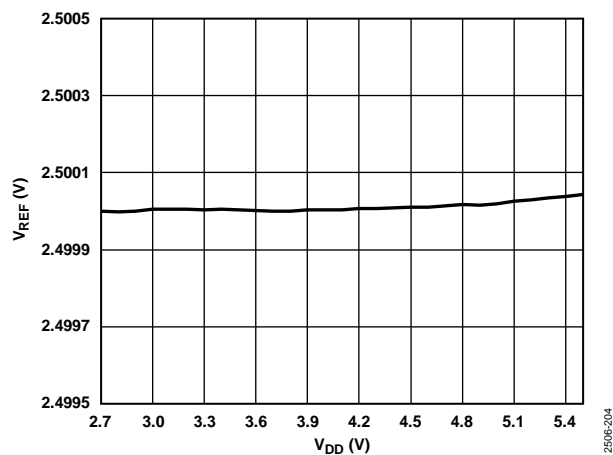


Figure 36. Reference Line Regulation

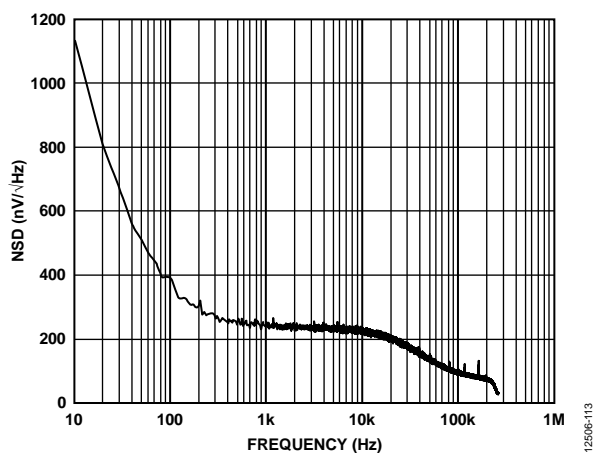


Figure 35. Reference Noise Spectral Density (NSD)

## TERMINOLOGY

### ADC TERMINOLOGY

#### Integral Nonlinearity (INL)

INL is the maximum deviation from a straight line passing through the endpoints of the ADC transfer function. The end-points of the transfer function are zero scale, a point that is 1 LSB below the first code transition, and full scale, a point that is 1 LSB above the last code transition.

#### Differential Nonlinearity (DNL)

DNL is the difference between the measured and the ideal 1 LSB change between any two adjacent codes in the ADC.

#### Offset Error

Offset error is the deviation of the first code transition (00 ... 000) to (00 ... 001) from the ideal, that is, AGND + 1 LSB.

#### Offset Error Match

Offset error match is the difference in offset error between any two channels.

#### Gain Error

Gain error is the deviation of the last code transition (111 ... 110) to (111 ... 111) from the ideal (that is,  $V_{REF} - 1$  LSB) after the offset error has been adjusted out.

#### Channel-to-Channel Isolation

Channel-to-channel isolation is a measure of the level of crosstalk between channels. It is measured by applying a full-scale, 5 kHz sine wave signal to all nonselected ADC input channels and determining how much that signal is attenuated in the selected channel. This specification is the worst case across all ADC channels for the [AD5592R/AD5592R-1](#).

#### Track-and-Hold Acquisition Time

The track-and-hold amplifier enters hold mode on the falling edge of SYNC and returns to track mode when the conversion is complete. The track-and-hold acquisition time is the minimum time required for the track-and-hold amplifier to remain in track mode for its output to reach and settle to within  $\pm 1$  LSB of the applied input signal, given a step change to the input signal.

#### Signal-to-Noise-and-Distortion (SINAD) Ratio

SINAD is the measured ratio of signal-to-noise-and-distortion at the output of the ADC. The signal is the rms amplitude of the fundamental. Noise is the sum of all nonfundamental signals up to half the sampling frequency ( $f_s/2$ ), excluding dc. The ratio is dependent on the number of quantization levels in the digitization process; the more levels, the smaller the quantization noise. The theoretical SINAD ratio for an ideal N-bit converter with a sine wave input is given by

$$SINAD \text{ (dB)} = 6.02N + 1.76$$

Thus, for a 12-bit converter, SINAD is 74 dB.

#### Total Harmonic Distortion (THD)

THD is the ratio of the rms sum of harmonics to the fundamental. For the [AD5592R/AD5592R-1](#), it is defined as

$$THD \text{ (dB)} = 20 \times \log \frac{\sqrt{V_2^2 + V_3^2 + V_4^2 + V_5^2 + V_6^2}}{V_1}$$

where:

$V_1$  is the rms amplitude of the fundamental.

$V_2$ ,  $V_3$ ,  $V_4$ ,  $V_5$ , and  $V_6$  are the rms amplitudes of the second through the sixth harmonics.

#### Peak Harmonic or Spurious Noise (SFDR)

Peak harmonic or spurious noise is defined as the ratio of the rms value of the next largest component in the ADC output spectrum (up to  $f_s/2$  and excluding dc) to the rms value of the fundamental. Normally, the value of this specification is determined by the largest harmonic in the spectrum, but for ADCs where the harmonics are buried in the noise floor, it is a noise peak.

## DAC TERMINOLOGY

### Relative Accuracy or Integral Nonlinearity (INL)

For the DAC, relative accuracy or integral nonlinearity is a measurement of the maximum deviation, in LSBs, from a straight line passing through the endpoints of the DAC transfer function. A typical INL vs. code plot is shown in Figure 17.

### Differential Nonlinearity (DNL)

Differential nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of  $\pm 1$  LSB maximum ensures monotonicity. This DAC is guaranteed monotonic by design. A typical DNL vs. code plot can be seen in Figure 18.

### Zero Code Error

Zero code error is a measurement of the output error when zero code (0x000) is loaded to the DAC register. Ideally, the output is 0 V. The zero code error is always positive in the [AD5592R/AD5592R-1](#) because the output of the DAC cannot go below 0 V due to a combination of the offset errors in the DAC and the output amplifier. Zero code error is expressed in mV.

### Gain Error

Gain error is a measure of the span error of the DAC. It is the deviation in slope of the DAC transfer characteristic from the ideal expressed as % FSR.

### Offset Error Drift

Offset error drift is a measurement of the change in offset error with a change in temperature. It is expressed in  $\mu\text{V}/^\circ\text{C}$ .

### Gain Temperature Coefficient

Gain temperature coefficient is a measurement of the change in gain error with changes in temperature. It is expressed in ppm of FSR/ $^\circ\text{C}$ .

### Offset Error

Offset error is a measurement of the difference between  $V_{\text{OUT}}$  (actual) and  $V_{\text{OUT}}$  (ideal), expressed in mV, in the linear region of the transfer function. Offset error can be negative or positive.

### DC Power Supply Rejection Ratio (PSRR)

PSRR indicates how the output of the DAC is affected by changes in the supply voltage. PSRR is the ratio of the change in  $V_{\text{OUT}}$  to a change in  $V_{\text{DD}}$  for a full-scale output of the DAC. It is measured in mV/V.  $V_{\text{REF}}$  is held at 2 V, and  $V_{\text{DD}}$  is varied by  $\pm 10\%$ .

### Output Voltage Settling Time

Output voltage settling time is the amount of time it takes for the output of a DAC to settle to a specified level for a  $\frac{1}{4}$  to  $\frac{3}{4}$  full-scale input change and is measured from the rising edge of  $\overline{\text{SYNC}}$ .

### Digital-to-Analog Glitch Impulse

Digital-to-analog glitch impulse is the impulse injected into the analog output when the input code in the DAC register changes state. It is normally specified as the area of the glitch in nV-sec, and is measured when the digital input code is changed by 1 LSB at the major carry transition (0x7FF to 0x800).

### Digital Feedthrough

Digital feedthrough is a measure of the impulse injected into the analog output of the DAC from the digital inputs of the DAC, but is measured when the DAC output is not updated. It is specified in nV-sec, and measured with a full-scale code change on the data bus, that is, from all 0s to all 1s and vice versa.

### Reference Feedthrough

Reference feedthrough is the ratio of the amplitude of the signal at the DAC output to the reference input when the DAC output is not being updated. It is expressed in dB.

### Noise Spectral Density

Noise spectral density is a measurement of the internally generated random noise. Random noise is characterized as a spectral density (nV/ $\sqrt{\text{Hz}}$ ). It is measured by loading the DAC to midscale and measuring noise at the output. It is measured in nV/ $\sqrt{\text{Hz}}$ .

### DC Crosstalk

DC crosstalk is the dc change in the output level of one DAC in response to a change in the output of another DAC. It is measured with a full-scale output change on one DAC (or soft power-down and power-up) while monitoring another DAC maintained at midscale. It is expressed in  $\mu\text{V}$ .

DC crosstalk due to load current change is a measure of the impact that a change in load current on one DAC has to another DAC kept at midscale. It is expressed in  $\mu\text{V}/\text{mA}$ .

### Digital Crosstalk

Digital crosstalk is the glitch impulse transferred to the output of one DAC at midscale in response to a full-scale code change (all 0s to all 1s and vice versa) in the input register of another DAC. It is measured in standalone mode and is expressed in nV-sec.

### Analog Crosstalk

Analog crosstalk is the glitch impulse transferred to the output of one DAC due to a change in the output of another DAC. It is measured by loading one of the input registers with a full-scale code change (all 0s to all 1s and vice versa), then executing a software LDAC (see Table 45 and Table 46), and monitoring the output of the DAC whose digital code was not changed. The area of the glitch is expressed in nV-sec.

### DAC-to-DAC Crosstalk

DAC-to-DAC crosstalk is the glitch impulse transferred to the output of one DAC due to a digital code change and subsequent analog output change of another DAC. It is measured by loading the attack channel with a full-scale code change (all 0s to all 1s and vice versa), using the write to and update commands while monitoring the output of the victim channel that is at midscale. The energy of the glitch is expressed in nV-sec.

### Multiplying Bandwidth

The amplifiers within the DAC have a finite bandwidth; the multiplying bandwidth is a measure of this. A sine wave on the reference (with full-scale code loaded to the DAC) appears on the output. The multiplying bandwidth is the frequency at which the output amplitude falls to 3 dB below the input.

**Voltage Reference Temperature Coefficient (TC)**

Voltage reference TC is a measure of the change in the reference output voltage with a change in temperature. The voltage reference TC is calculated using the box method, which defines the TC as the maximum change in the reference output over a given temperature range expressed in ppm/°C, as follows:

$$TC = \left[ \frac{V_{REF(MAX)} - V_{REF(MIN)}}{V_{REF(NOM)} \times Temp\ Range} \right] \times 10^6$$

where:

$V_{REF(MAX)}$  is the maximum reference output measured over the total temperature range.

$V_{REF(MIN)}$  is the minimum reference output measured over the total temperature range.

$V_{REF(NOM)}$  is the nominal reference output voltage, 2.5 V.

*Temp Range* is the specified temperature range of –40°C to +105°C.

## THEORY OF OPERATION

The AD5592R/AD5592R-1 are 8-channel configurable analog and digital input/output ports. The AD5592R/AD5592R-1 have eight pins that can be independently configured as a 12-bit DAC output channel, a 12-bit ADC input channel, a digital input pin, or a digital output pin.

The function of each pin is determined by programming the ADC, DAC, or GPIO configuration registers as appropriate. See the Configuring the AD5592R/AD5592R-1 section and Table 16 for more information.

### DAC SECTION

The AD5592R/AD5592R-1 contain eight 12-bit DACs and implement a segmented string DAC architecture with an internal output buffer. Figure 37 shows the internal block diagram of the DAC architecture.

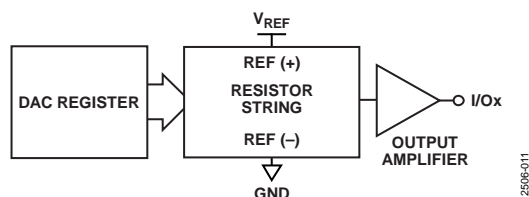


Figure 37. Internal Block Diagram of the DAC Architecture

The DAC channels have a shared gain bit that sets the output range as 0 V to  $V_{REF}$  or 0 V to  $2 \times V_{REF}$ . Because the gain bit is shared by all channels, it is not possible to set different output ranges on a per channel basis. The input coding to the DAC is straight binary. The ideal output voltage is given by

$$V_{OUT} = G \times V_{REF} \times \left( \frac{D}{2^N} \right)$$

where:

$D$  is the decimal equivalent of the binary code (0 to 4095) that is loaded to the DAC register.

$G = 1$  for an output range of 0 V to  $V_{REF}$ , or  $G = 2$  for an output range of 0 V to  $2 \times V_{REF}$ .

$N = 12$ .

### Resistor String

The simplified segmented resistor string DAC structure is shown in Figure 38. The code loaded to the DAC register determines the switch on the string that is connected to the output buffer.

Because each resistance in the string has the same value,  $R$ , the string DAC is guaranteed monotonic.

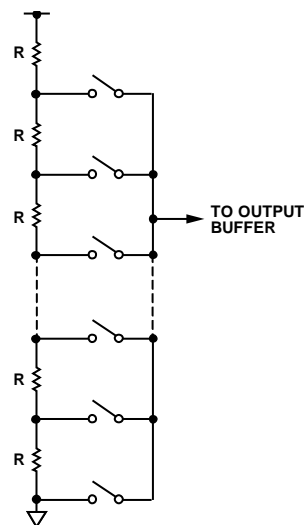


Figure 38. Simplified Resistor String Structure

### Output Buffer

The output buffer is designed as an input/output rail-to-rail buffer. The output buffer can drive 2 nF capacitance with a 1 k $\Omega$  resistor in parallel. The slew rate is 1.25 V/ $\mu$ s with a  $\frac{1}{4}$  to  $\frac{3}{4}$  scale settling time of 6  $\mu$ s. By default, the DAC outputs update directly after data has been written to the input register. The LDAC register is used to delay the updates until additional channels have been written to, if required. See the Readback and LDAC Mode Register section for more information.

ADC SECTION

The 12-bit, single-supply ADC is capable of throughput rates of 400 kSPS. The ADC is preceded by a multiplexer that switches selected I/Ox pins to the ADC. A sequencer is included to automatically switch the multiplexer to the next selected channel. Channels are selected for conversion by writing to the ADC sequence register. When the write to the ADC sequence register has completed, the first channel in the conversion sequence is put into track mode. Allow each channel to track the input signal for a minimum of 500 ns. The first SYNC falling edge following the write to the ADC sequence register begins the conversion of the first channel in the sequence. The next SYNC falling edge starts a conversion on the second channel in the sequence and also begins to clock the first ADC result onto the serial interface. ADC data is clocked out of the AD5592R in a 16-bit frame. D15 is 0 to indicate that the data contains ADC data, D14 to D12 is the binary representation of the ADC address, and D11 to D0 is the ADC result (see Table 12).

Each conversion takes 2 μs, and the conversion must be completed before another conversion is initiated. Only write to the AD5592R/AD5592R-1 when no conversion is taking place. I/O7 can be configured as a BUSY signal to indicate when a conversion is taking place. BUSY goes low while a conversion is in progress, and high when an ADC result is available. The ADC has an input range selection bit (Bit D5 in the general-purpose control register), which sets the input range as 0 V to VREF or 0 V to 2 × VREF. All input channels share the same range. The output coding of the ADC is straight binary. It is possible to set each I/Ox pin as both a DAC and an ADC. When an I/Ox pin is set as both a DAC and an ADC, the primary function is that of the DAC. If the pin is selected for inclusion in an ADC conversion sequence, the voltage on the pin is converted and made available via the serial interface, allowing the DAC voltage to be monitored.

Calculating ADC Input Current

The current flowing into the I/Ox pins configured as ADC inputs vary with the sampling rate (fs), the voltage difference between successive channels (VDIFF), and whether buffered or unbuffered mode is used. Figure 39 shows a simplified version of the ADC input structure. When a new channel is selected for conversion, the 5.8 pF capacitor must be charged or discharged of the voltage that was on the previously selected channel. The time required by the charge or discharge depends on the voltage difference between the two channels. This affects the input impedance of the multiplexer and therefore the input current flowing into the I/Ox pins. In buffered mode, Switch S1 is open and Switch S2 is closed, in which case the U1 buffer is directly driving the 23.1 pF capacitor, and its charging time is negligible. In unbuffered mode, Switch S1 is closed and Switch S2 is closed. In unbuffered mode, the 23.1 pF capacitor must be charged from the I/Ox pins, which contributes to the input current. For applications where the ADC input current is too high, an external input buffer may be required. The choice of buffer is a function of the particular application.

Calculate the input current for buffered mode as follows:

fs × C × VDIFF + 1 nA

where:

fs is the ADC sample rate in Hertz.

C is the sampling capacitance in Farads.

VDIFF is the voltage change between successive channels.

1 nA is the dc leakage current associated with buffered mode.

Calculate the input current for unbuffered mode as follows:

fs × C × VDIFF

An example solution is as follows: for the ADC input current in buffered mode, where I/O0 = 0.5 V, I/O1 = 2 V, and fs = 10 kHz,

(10,000 × 5.8 × 10<sup>-12</sup> × 1.5) + 1 nA = 88 nA

Under the same conditions, the ADC input current in unbuffered mode is as follows:

(10,000 × 28.9 × 10<sup>-12</sup> × 1.5) = 433.5 nA

Table 12. ADC Conversion Format

| MSB |             |     |     | LSB             |  |  |  |
|-----|-------------|-----|-----|-----------------|--|--|--|
| D15 | D14         | D13 | D12 | D11 to D0       |  |  |  |
| 0   | ADC address |     |     | 12-bit ADC data |  |  |  |

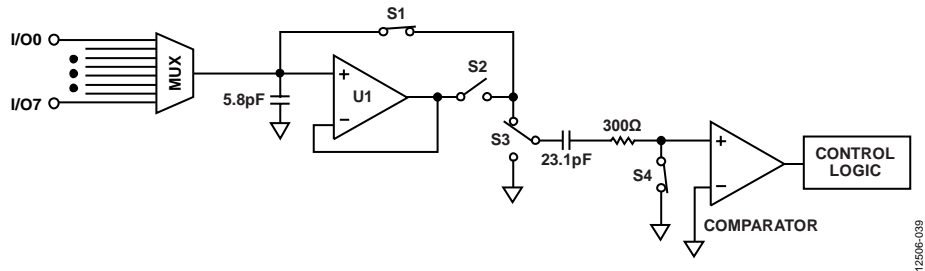


Figure 39. ADC Input Structure



## GPIO SECTION

Each of the eight I/Ox pins can be configured as a general-purpose digital input pin by programming the GPIO read configuration register or as a digital output pin by programming the GPIO write configuration register. When an I/Ox pin is configured as an output, the pin can be set high or low by programming the GPIO write data register. Logic levels for general-purpose outputs are relative to  $V_{DD}$  and GND. When an I/Ox pin is configured as an input, its status can be determined by setting Bit D10 in the GPIO read configuration register (see Table 37). The next SPI operation clocks out the state of the GPIO pins. When an I/Ox pin is set as an output, it is possible to read its status by also setting it as an input pin. When reading the status of the I/Ox pins set as inputs, the status of an I/Ox pin set as both an input and output pin is also returned.

## INTERNAL REFERENCE

The AD5592R/AD5592R-1 contain an on-chip 2.5 V reference. The reference is powered down by default and is enabled by setting Bit D9 in the power-down register to 1 (see Table 43). When the on-chip reference is powered up, the reference voltage appears on the  $V_{REF}$  pin and may be used as a reference source for other components. When the internal reference is used, it is recommended to decouple the internal reference to GND using a 100 nF capacitor. It is recommended that the internal reference be buffered before using it elsewhere in the system. When the reference is powered down, an external reference must be connected to the  $V_{REF}$  pin. Suitable external reference sources for the AD5592R/AD5592R-1 include the AD780, AD1582, ADR431, REF193, and ADR391.

## RESET FUNCTION

The AD5592R/AD5592R-1 have an asynchronous  $\overline{\text{RESET}}$  pin. For normal operation,  $\overline{\text{RESET}}$  is tied high. A falling edge on  $\overline{\text{RESET}}$  resets all registers to their default values and reconfigures the I/Ox pins to their default values (85 k $\Omega$  pull-down to GND). The reset function takes 250  $\mu\text{s}$  maximum; do not write new data to the AD5592R/AD5592R-1 during this time. The AD5592R/AD5592R-1 have a software reset that performs the same function as the  $\overline{\text{RESET}}$  pin. The reset function is activated by writing 0x5AC to the reset register (see Table 44).

## TEMPERATURE INDICATOR

The AD5592R/AD5592R-1 contain an integrated temperature indicator, which can be read to provide an estimation of the die temperature. The temperature reading can be used in fault detection where a sudden rise in die temperature may indicate a fault condition such as a shorted output. Temperature readback is enabled by setting Bit D8 in the ADC sequence register to 1 (see Table 28). The temperature result is then added to the ADC sequence. The temperature result has an address of 0b1000; take care that this result is not confused with the readback from DAC0. The temperature conversion takes 5  $\mu\text{s}$  with the ADC buffer enabled and 20  $\mu\text{s}$  when the buffer is disabled. Calculate the temperature by using the following formulae:

For ADC gain = 1,

$$\text{Temperature } (^{\circ}\text{C}) = 25 + \frac{(ADC \text{ Code} - (0.5/V_{REF}) \times 4095)}{(2.654 \times (2.5/V_{REF}))}$$

For ADC gain = 2,

$$\text{Temperature } (^{\circ}\text{C}) = 25 + \frac{(ADC \text{ Code} - (0.5/(2 \times V_{REF})) \times 4095)}{(1.327 \times (2.5/V_{REF}))}$$

The range of codes returned by the ADC when reading from the temperature indicator is approximately 645 to 1035, corresponding to a temperature between  $-40^{\circ}\text{C}$  to  $+105^{\circ}\text{C}$ . The accuracy of the temperature indicator, averaged over five samples, is typically  $3^{\circ}\text{C}$ .

## SERIAL INTERFACE

The AD5592R/AD5592R-1 have a serial interface ( $\overline{\text{SYNC}}$ , SCLK, SDI, and SDO), which is compatible with SPI standards, as well as with most DSPs. The input shift register is 16 bits wide (see Table 13). The MSB (D15) determines what type of write function is required. When D15 is 0, a write to the control register is required. The control register address is selected by D14 to D11. D10 and D9 are reserved and are 0s. D8 to D0 set the data that is written to the selected control register. When D15 is 1, data is written to a DAC channel (assuming that channel has been set to be a DAC). D14 to D12 select which DAC is addressed. D11 to D0 is the 12-bit data loaded to the selected DAC, with D11 being the MSB of the DAC data. Table 14 shows the control register map for the AD5592R/AD5592R-1. The register map allows the operation of each of the I/O pins to be configured. ADCs can be selected for inclusion in sampling sequences. DACs can be updated individually or simultaneously (see the LDAC Mode Operation section). GPIO settings are also controlled via the register map.

### POWER-UP TIME

When power is applied to the AD5592R/AD5592R-1, the power-on reset block begins to configure the device and to load the registers with their default values. The configuration process takes 250  $\mu\text{s}$ ; do not write to any of the registers during this time.

Table 13. Input Shift Register Format

| MSB |                          |     |     |                 |     |    |                       |    |    |    |    |    |    | LSB |    |
|-----|--------------------------|-----|-----|-----------------|-----|----|-----------------------|----|----|----|----|----|----|-----|----|
| D15 | D14                      | D13 | D12 | D11             | D10 | D9 | D8                    | D7 | D6 | D5 | D4 | D3 | D2 | D1  | D0 |
| 0   | Control register address |     |     |                 | 0   | 0  | Control register data |    |    |    |    |    |    |     |    |
| 1   | DAC address              |     |     | 12-bit DAC data |     |    |                       |    |    |    |    |    |    |     |    |

Table 14. Control Register Map

| MSB (D15) | Address (D14 to D11) | Name                                  | Description  | Default Value |
|-----------|----------------------|---------------------------------------|--|---------------|
| 0         | 0000                 | NOP                                   | No operation   | 0x000         |
| 0         | 0001                 | DAC readback                          | Selects and enables DAC readback   | 0x000         |
| 0         | 0010                 | ADC sequence register                 | Selects ADCs for conversion  | 0x000         |
| 0         | 0011                 | General-purpose control register      | DAC and ADC control register   | 0x000         |
| 0         | 0100                 | ADC pin configuration                 | Selects which pins are ADC inputs  | 0x000         |
| 0         | 0101                 | DAC pin configuration                 | Selects which pins are DAC outputs   | 0x000         |
| 0         | 0110                 | Pull-down configuration               | Selects which pins have a 85 k $\Omega$ pull-down resistor to GND                                      | 0x0FF         |
| 0         | 0111                 | Readback and LDAC mode                | Selects the operation of the Load DAC (LDAC) function and/or which configuration register is read back | 0x000         |
| 0         | 1000                 | GPIO write configuration <sup>1</sup> | Selects which pins are general-purpose outputs   | 0x000         |
| 0         | 1001                 | GPIO write data                       | Writes data to the general-purpose outputs   | 0x000         |
| 0         | 1010                 | GPIO read configuration               | Selects which pins are general-purpose inputs  | 0x000         |
| 0         | 1011                 | Power-down/reference control          | Powers down DACs and enables/disables the reference  | 0x000         |
| 0         | 1100                 | GPIO open-drain configuration         | Selects open-drain or push/pull for general-purpose outputs  | 0x000         |
| 0         | 1101                 | Three-state configuration             | Selects which pins are three-state   | 0x000         |
| 0         | 1110                 | Reserved                              | Reserved   |               |
| 0         | 1111                 | Software reset                        | Resets the AD5592R/AD5592R-1   | 0x000         |
| 1         | XXX <sup>2</sup>     | DAC write                             | Writes to addressed DAC register   | 0x000         |

<sup>1</sup> This register is also used to set I/O7 as a  $\overline{\text{BUSY}}$  output.

<sup>2</sup> D14 to D11 is the DAC register address (see Table 13).

### WRITE MODE

Figure 4 shows the read and write timing for the AD5592R/AD5592R-1. A write sequence begins by bringing the  $\overline{\text{SYNC}}$  line low. Data on SDI is clocked into the 16-bit shift register on the falling edge of SCLK. After the 16th falling clock edge, the last data bit is clocked in.  $\overline{\text{SYNC}}$  is brought high, and the programmed function is executed (that is, a change in a DAC input register or a change in a control register).  $\overline{\text{SYNC}}$  must be brought high for a minimum of 20 ns before the next write. All interface pins must be operated close to the  $V_{\text{DD}}$  or  $V_{\text{LOGIC}}$  rails to minimize power consumption in the digital input buffers.

### READ MODE

The AD5592R/AD5592R-1 allow data readback from the ADCs and control registers via the serial interface. ADC conversions are automatically clocked out on the serial interface as part of a sequence or as a single ADC conversion. Reading from a register first requires a write to the readback and LDAC mode register to select the register to read back. The contents of the selected register are clocked out on the next 16 SCLKs following a falling edge of  $\overline{\text{SYNC}}$ . Note that due to timing requirements of  $t_{10}$  (25 ns), the maximum speed of the SPI interface during a read operation must not exceed 20 MHz.

## CONFIGURING THE AD5592R/AD5592R-1

The AD5592R/AD5592R-1 I/Ox pins are configured by writing to a series of configuration registers. The control registers are accessed when the MSB of a serial write is 0, as shown in Table 13. The control register map for the AD5592R/AD5592R-1 is shown in Table 14. At power-up, the I/Ox pins are configured as 85 k $\Omega$  pull-down resistors connected to GND.

The input/output channels of the AD5592R/AD5592R-1 can be configured to operate as DAC outputs, ADC inputs, digital outputs, digital inputs, three-state, or connected to GND with 85 k $\Omega$  pull-down resistors. When configured as digital outputs, the I/Ox pins have the additional option of being configured as push/pull or open-drain. The input/output channels are configured by writing to the appropriate configuration registers, as shown in Table 15 and Table 16. To assign a particular function to an input/output channel, the user writes to the appropriate register and sets the corresponding bit to 1. For example, setting Bit D0 in the DAC configuration register to 1 configures I/O0 as a DAC (see Table 20).

In the event that the bit for an input/output channel is set in multiple configuration registers, the input/output channel takes the function dictated by the last write operation. The exceptions to this rule are that an I/Ox pin can be set as both a DAC and an ADC or

as a digital input and output. When an I/Ox pin is configured as a DAC and ADC, its primary function is as a DAC, and the ADC can measure the voltage being provided by the DAC. This feature can monitor the output voltage to detect short circuits or overload conditions.

When a pin is configured as both a general-purpose input and output, the primary function is as an output pin. This configuration allows the status of the output pin to be determined by reading the GPIO register. Figure 40 shows a typical configuration example where I/O0 and I/O1 are configured as ADCs, I/O2 and I/O3 are configured as DACs, I/O4 is a general-purpose output pin, I/O5 is a general-purpose input pin, and I/O6 and I/O7 are three-state.

The general-purpose control register also contains other functions associated with the DAC and ADC, such as the lock configuration bit. When the lock configuration bit is set to 1, any writes to the pin configuration registers are ignored, thus preventing the function of the I/Ox pins from being changed.

The I/Ox pins can be reconfigured at any time when the AD5592R/AD5592R-1 is in an idle state, that is, no ADC conversions are taking place and no registers are being read back. The lock configuration bit must also be 0.

**Table 15. I/Ox Pin Configuration Registers**

| MSB |                  |     |     |     |          |    |    |     |     |     |     |     |     | LSB |     |
|-----|------------------|-----|-----|-----|----------|----|----|-----|-----|-----|-----|-----|-----|-----|-----|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8 | D7  | D6  | D5  | D4  | D3  | D2  | D1  | D0  |
| 0   | Register address |     |     |     | Reserved |    |    | IO7 | IO6 | IO5 | IO4 | IO3 | IO2 | IO1 | IO0 |

**Table 16. Bit Descriptions for the I/Ox Pin Configuration Registers**

| Bit(s)     | Bit Name         | Description  |
|------------|------------------|--|
| D15        | MSB              | Set this bit to 0.   |
| D14 to D11 | Register address | Selects which pin configuration register is addressed.<br>0100: ADC pin configuration.<br>0101: DAC pin configuration.<br>0110: pull-down configuration. (Default condition at power-up.)<br>1000: GPIO write configuration.<br>1010: GPIO read configuration.<br>1100: GPIO open-drain configuration.<br>1101: three-state configuration. |
| D10 to D8  | Reserved         | Reserved. Set these bits to 0.   |
| D7 to D0   | IO7 to IO0       | Enable register function on selected I/Ox pin.<br>0: no function selected.<br>1: set the selected I/Ox pin to the register function.   |

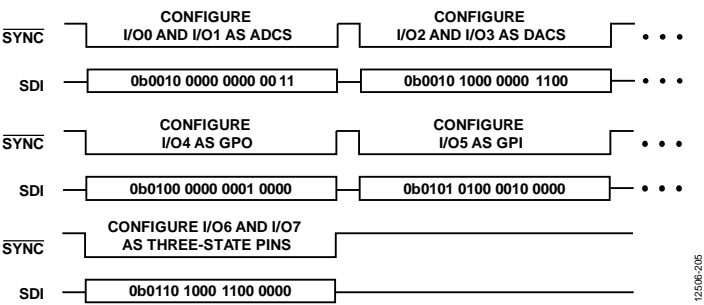


Figure 40. Typical Configuration Example

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**GENERAL-PURPOSE CONTROL REGISTER**

The general-purpose control register enables or disables certain functions associated with the DAC, ADC, and I/Ox pin configuration (see Table 17 and Table 18). The general-purpose control register sets the gain of the DAC and ADC. Bit D5 sets the input range for the ADC, and Bit D4 sets the output range of the DAC.

The general-purpose control register also enables/disables the ADC buffer and precharge function (see the ADC Section for more details). The register can also be used to lock the I/Ox pin configuration to prevent accidental change. When Bit D7 is set to 1, writes to the configuration registers are ignored.

**Table 17. General-Purpose Control Register**

| MSB |                  |     |     |     |          |                      |                   |      |          |           |           | LSB      |    |    |    |
|-----|------------------|-----|-----|-----|----------|----------------------|-------------------|------|----------|-----------|-----------|----------|----|----|----|
| D15 | D14              | D13 | D12 | D11 | D10      | D9                   | D8                | D7   | D6       | D5        | D4        | D3       | D2 | D1 | D0 |
| 0   | Register address |     |     |     | Reserved | ADC buffer precharge | ADC buffer enable | Lock | All DACs | ADC range | DAC range | Reserved |    |    |    |

**Table 18. Bit Descriptions for the General-Purpose Control Register**

| Bit(s)     | Bit Name             | Description   |
|------------|----------------------|---|
| D15        | MSB                  | Set this bit to 0.  |
| D14 to D11 | Register address     | Set these bits to 0b0011.   |
| D10        | Reserved             | Reserved. Set this bit to 0.  |
| D9         | ADC buffer precharge | ADC buffer precharge.<br>0: ADC buffer is not used to precharge the ADC. If the ADC buffer is enabled, it is always powered up (default).<br>1: ADC buffer is used to precharge the ADC. If the ADC buffer is enabled, it is powered up while the conversion takes place and then powered down until the next conversion takes place. |
| D8         | ADC buffer enable    | ADC buffer enable.<br>0: ADC buffer is disabled (default).<br>1: ADC buffer is enabled.   |
| D7         | Lock                 | Lock configuration.<br>0: the contents of the I/Ox pin configuration registers can be changed (default).<br>1: the contents of the I/Ox pin configuration registers cannot be changed.  |
| D6         | All DACs             | Write all DACs.<br>0: for future DAC writes, the DAC address bits determine which DAC is written to (default).<br>1: for future DAC writes, the DAC address bits are ignored, and all channels configured as DACs are updated with the same data.   |
| D5         | ADC range            | ADC input range select.<br>0: ADC gain is 0 V to $V_{REF}$ (default).<br>1: ADC gain is 0 V to $2 \times V_{REF}$ .   |
| D4         | DAC range            | DAC output range select.<br>0: DAC output range is 0 V to $V_{REF}$ (default).<br>1: DAC output range is 0 V to $2 \times V_{REF}$ .  |
| D3 to D0   | Reserved             | Reserved. Set these bits to 0.  |

## DAC WRITE OPERATION

To set a pin as a DAC, set the appropriate bit in the DAC pin configuration register to 1 (see Table 19 and Table 20). For example, setting Bit 0 to Bit 1 enables I/O0 as a DAC output. Data is written to a DAC when the MSB (D15) of the serial write is 1. D14, D13, and D12 determine which DAC is addressed, and D11 to D0 contain the 12-bit data to be written to the DAC, as shown in Table 21 and Table 22. Data is written to the selected DAC input register. Data written to the input register can be automatically copied to the DAC register, if required. Data is transferred to the DAC register based on the setting of the LDAC mode register (see Table 45 and Table 46).

## LDAC Mode Operation

When the LDAC mode bits (D1 and D0) are 00 respectively, new data is automatically transferred from the input register to the DAC register, and the analog output updates. When the LDAC mode bits are 01, data remains in the input register. This LDAC mode allows writes to input registers without affecting the analog outputs. When the input registers have been loaded with the desired values, setting the LDAC mode bits to 10 transfers the values in the input registers to the DAC registers, and the analog outputs update simultaneously. The LDAC mode bits then revert back to 01, assuming their previous setting was 01. See Table 45 and Table 46.

**Table 19. DAC Pin Configuration Register**

| MSB |                  |     |     |     |          |    |    |      |      | LSB  |      |      |      |      |      |
|-----|------------------|-----|-----|-----|----------|----|----|------|------|------|------|------|------|------|------|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8 | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
| 0   | Register address |     |     |     | Reserved |    |    | DAC7 | DAC6 | DAC5 | DAC4 | DAC3 | DAC2 | DAC1 | DAC0 |

**Table 20. Bit Descriptions for the DAC Pin Configuration Register**

| Bit(s)     | Bit Name         | Description  |
|------------|------------------|--|
| D15        | MSB              | Set this bit to 0.   |
| D14 to D11 | Register address | Set these bits to 0b0101.  |
| D10 to D8  | Reserved         | Reserved. Set these bits to 0.   |
| D7 to D0   | DAC7 to DAC0     | Select I/Ox pins as DAC outputs.<br>1: I/Ox is a DAC output.<br>0: I/Ox function is determined by the pin configuration registers (default). |

**Table 21. DAC Write Register**

| MSB |             |     |     |                 |  |     |    |    |    |    |    |    |    |    | LSB |    |
|-----|-------------|-----|-----|-----------------|--|-----|----|----|----|----|----|----|----|----|-----|----|
| D15 | D14         | D13 | D12 | D11 (MSB)       |  | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1  | D0 |
| 1   | DAC address |     |     | 12-bit DAC data |  |     |    |    |    |    |    |    |    |    |     |    |

**Table 22. Bit Descriptions for the DAC Data Register**

| Bit(s)     | Bit Name        | Description  |
|------------|-----------------|--|
| D15        | MSB             | Set this bit to 1.   |
| D14 to D12 | DAC address     | Bit D14 to Bit D12 select the DAC register to which the data in D11 to D0 is loaded.<br>000: DAC0<br>001: DAC1<br>010: DAC2<br>011: DAC3<br>100: DAC4<br>101: DAC5<br>110: DAC6<br>111: DAC7 |
| D11 to D0  | 12-bit DAC data | 12-bit DAC data.   |

## DAC READBACK

The input register of each DAC can be read back via the SPI interface. Reading back the DAC register value can be used to confirm that the data was received correctly before writing to the LDAC register, or to check what value was last loaded to a DAC. Data can only be read back from a DAC when there is no ADC conversion sequence taking place.

To read back a DAC input register, it is first necessary to enable the readback function and select which DAC register is required.

This is achieved by writing to the DAC read back register (shown in Table 23 and Table 24). Set the D4 and D3 bits to 1 to enable the readback function. The D2 to D0 bits select which DAC data is required. The DAC data is clocked out of the [AD5592R/AD5592R-1](#) on the subsequent SPI operation. Figure 41 shows an example of setting I/O3, configured as a DAC, to midscale. The input data is then read back. D14 to D12 contain the address of the DAC register being read back, and D15 is 1.

**Table 23. DAC Readback Register**

| MSB |                  |     |     |     |     |          |    |    |    |    | LSB                 |    |             |    |    |
|-----|------------------|-----|-----|-----|-----|----------|----|----|----|----|---------------------|----|-------------|----|----|
| D15 | D14              | D13 | D12 | D11 | D10 | D9       | D8 | D7 | D6 | D5 | D4                  | D3 | D2          | D1 | D0 |
| 0   | Register address |     |     |     |     | Reserved |    |    |    |    | Enable DAC readback |    | DAC channel |    |    |

**Table 24. Bit Descriptions for the DAC Readback Register**

| Bit(s)     | Bit Name            | Description   |
|------------|---------------------|---|
| D15        | MSB                 | Set this bit to 0.  |
| D14 to D11 | Register address    | Set these bits to 0b0001.   |
| D10 to D5  | Reserved            | Reserved. Set these bits to 0.  |
| D4 and D3  | Enable DAC readback | Enable readback of the DAC input register.<br>11: readback enabled.<br>00: readback disabled (default). |
| D2 to D0   | DAC channel         | Select DAC channel.<br>000: DAC0<br>001: DAC1<br>...<br>110: DAC6<br>111: DAC7                          |

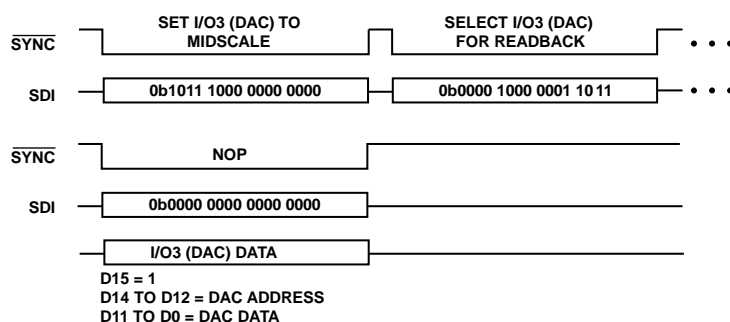


Figure 41. DAC Readback Operation

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## ADC OPERATION

To set a pin as an ADC, set the appropriate bit in the ADC pin configuration register to 1 (see Table 25 and Table 26). For example, setting Bit 0 to Bit 1 enables I/O0 as an ADC input. The ADC channels of the AD5592R/AD5592R-1 operate as a traditional multichannel ADC, where each serial transfer selects the next channel for conversion. Writing to the ADC sequence register (see Table 27 and Table 28) selects the ADC channels to be included in the sequence, and the REP bit determines if the sequence is repeated. The SYNC signal is used to frame the write to the converter on the SDI pin. The data that appears on the SDO pin during the initial write to the ADC sequence register is invalid. When the sequence register is written to, the ADC begins to track the first channel in the sequence. Tracking takes 500 ns; do not initiate a conversion until this time has passed. The next SYNC falling edge initiates a conversion on the selected channel. The subsequent SYNC falling edge begins clocking out the ADC result and also initiates the next conversion. The ADC operates with one cycle latency, thus the conversion result corresponding to each conversion is available one serial read cycle after the cycle in which the conversion was initiated.

If more than one channel is selected in the ADC sequence register, the ADC converts all selected channels sequentially in ascending order on successive SYNC falling edges. Once all the selected

channels in the control register are converted, the ADC repeats the sequence if the REP bit is set. If the REP bit is clear, the ADC goes three-state. Figure 42 to Figure 45 show typical ADC modes of operation. I/O7 can be configured as a BUSY output pin to indicate when a conversion result is available. BUSY goes low while a conversion takes place and goes high when the conversion result is available. The conversion result is clocked out on the SDO pin on the following read/write operation. For an ADC conversion, D15 is 0, D14 to D12 contain the ADC address, and D11 to D0 contain the 12-bit conversion result, as shown in Table 29.

### Changing an ADC Sequence

The channels included in an ADC sequence can be changed by first stopping an existing conversion sequence (see Figure 46). The ADC conversion sequence is stopped by clearing the REP, TEMP, and ADC7 to ADC0 bits in the ADC sequence register to 0.

As the command to stop the sequence is written, an ADC conversion is also taking place. This conversion must finish before a new sequence can be written to the ADC sequence register. Allow a minimum of 2  $\mu$ s between starting the write to end the current sequence and starting the write to select a new sequence. After selecting the new sequence, allow an ADC track time of 500 ns before initiating the next conversion.

Table 25. ADC Pin Configuration Register

| MSB |                  |     |     |     |          |    |    |      |      |      |      |      |      | LSB  |      |
|-----|------------------|-----|-----|-----|----------|----|----|------|------|------|------|------|------|------|------|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8 | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
| 0   | Register address |     |     |     | Reserved |    |    | ADC7 | ADC6 | ADC5 | ADC4 | ADC3 | ADC2 | ADC1 | ADC0 |

Table 26. Bit Descriptions for the ADC Pin Configuration Register

| Bit(s)     | Bit Name         | Description   |
|------------|------------------|---|
| D15        | MSB              | Set this bit to 0.  |
| D14 to D11 | Register address | Set these bits to 0b0100.   |
| D10 to D8  | Reserved         | Reserved. Set these bits to 0.  |
| D7 to D0   | ADC7 to ADC0     | Select I/Ox pins as ADC inputs.<br>1: I/Ox is an ADC input.<br>0: I/Ox function is determined by the pin configuration registers (default). |



Table 27. ADC Sequence Register

| MSB |                  |     |     |     |          |     |      |      |      |      |      |      |      |      | LSB  |  |
|-----|------------------|-----|-----|-----|----------|-----|------|------|------|------|------|------|------|------|------|--|
| D15 | D14              | D13 | D12 | D11 | D10      | D9  | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |  |
| 0   | Register address |     |     |     | Reserved | REP | TEMP | ADC7 | ADC6 | ADC5 | ADC4 | ADC3 | ADC2 | ADC1 | ADC0 |  |

Table 28. Bit Descriptions for the ADC Sequence Register

| Bit(s)     | Bit Name         | Description  |
|------------|------------------|--|
| D15        | MSB              | Set this bit to 0.   |
| D14 to D11 | Register address | Set these bits to 0b0010.  |
| D10        | Reserved         | Reserved. Set these bits to 0.   |
| D9         | REP              | ADC sequence repetition.<br>0: sequence repetition disabled (default).<br>1: sequence repetition enabled.  |
| D8         | TEMP             | Include temperature indicator in ADC sequence.<br>0: disable temperature indicator readback (default).<br>1: enable temperature indicator readback.  |
| D7 to D0   | ADC7 to ADC0     | Include ADC channels in conversion sequence.<br>0: the selected ADC channel is not included in the conversion sequence.<br>1: include the selected ADC channel in the conversion sequence. |

Table 29. ADC Conversion Result

| MSB |                          |     |     |     |                   |    |    |    |    |    |    |    |    |    | LSB |  |
|-----|--------------------------|-----|-----|-----|-------------------|----|----|----|----|----|----|----|----|----|-----|--|
| D15 | D14                      | D13 | D12 | D11 | D10               | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0  |  |
| 0   | ADC address <sup>1</sup> |     |     |     | 12-bit ADC result |    |    |    |    |    |    |    |    |    |     |  |

<sup>1</sup> The ADC addresses are as follows: 000 = ADC0 ... 111 = ADC7.

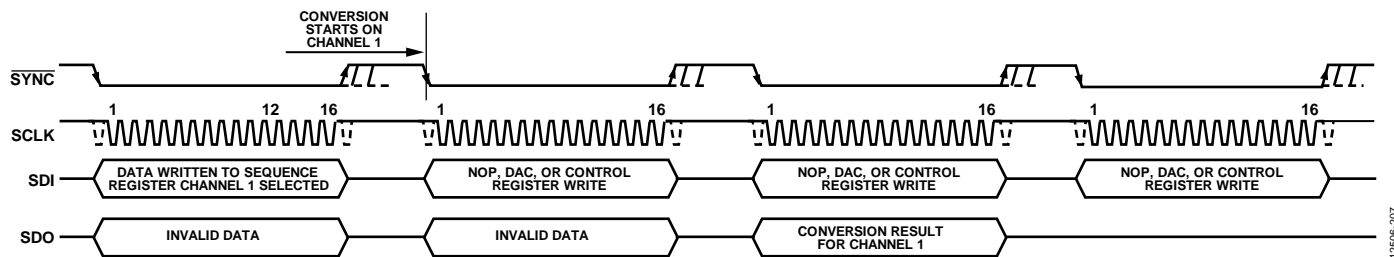


Figure 42. Single-Channel ADC Conversion Sequence, No Repeat

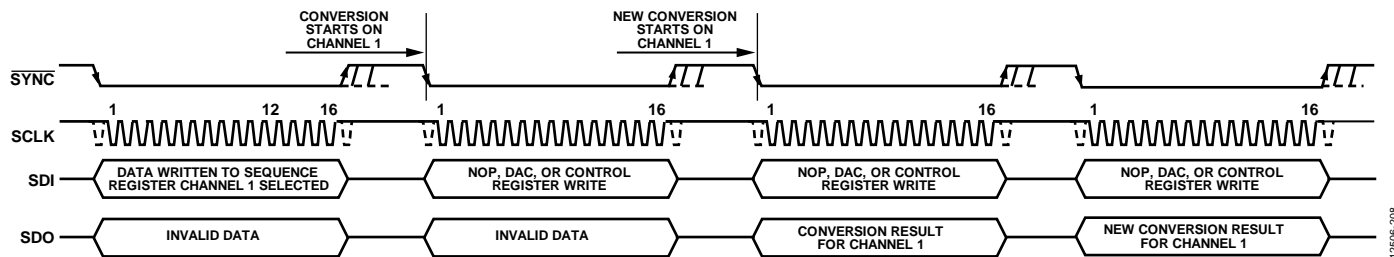


Figure 43. Single-Channel, Repeating, ADC Conversion Sequence

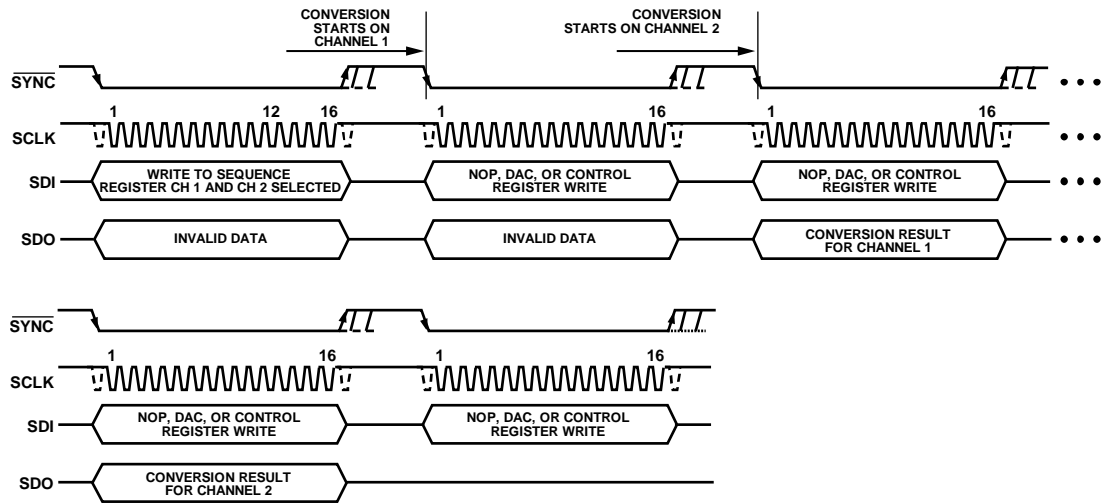


Figure 44. Multichannel ADC Conversion Sequence, No Repeat

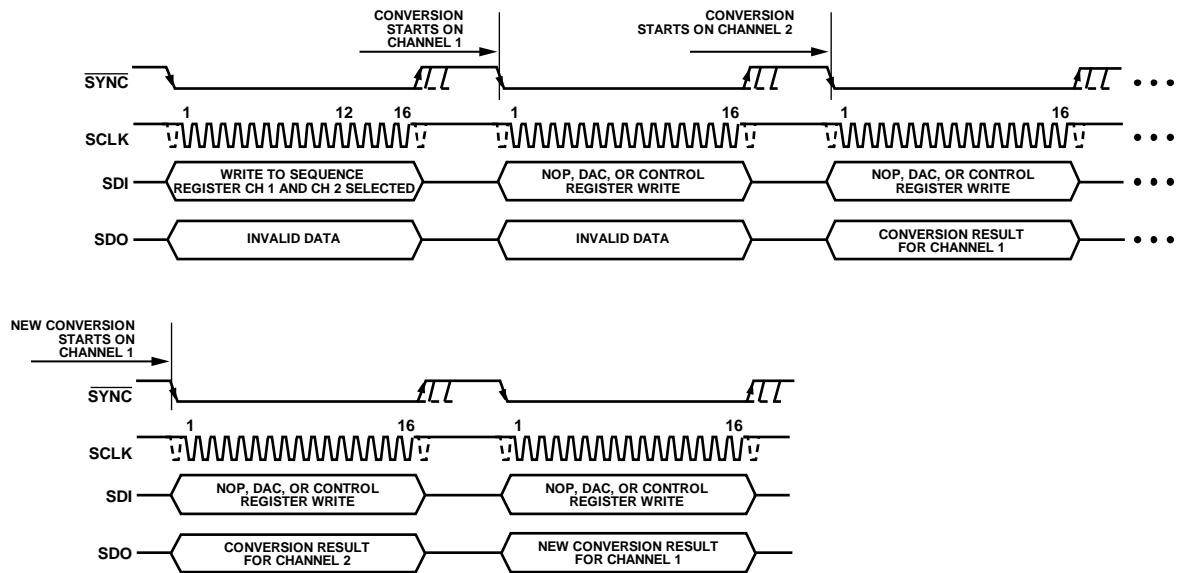


Figure 45. Multichannel, Repeating, ADC Conversion Sequence

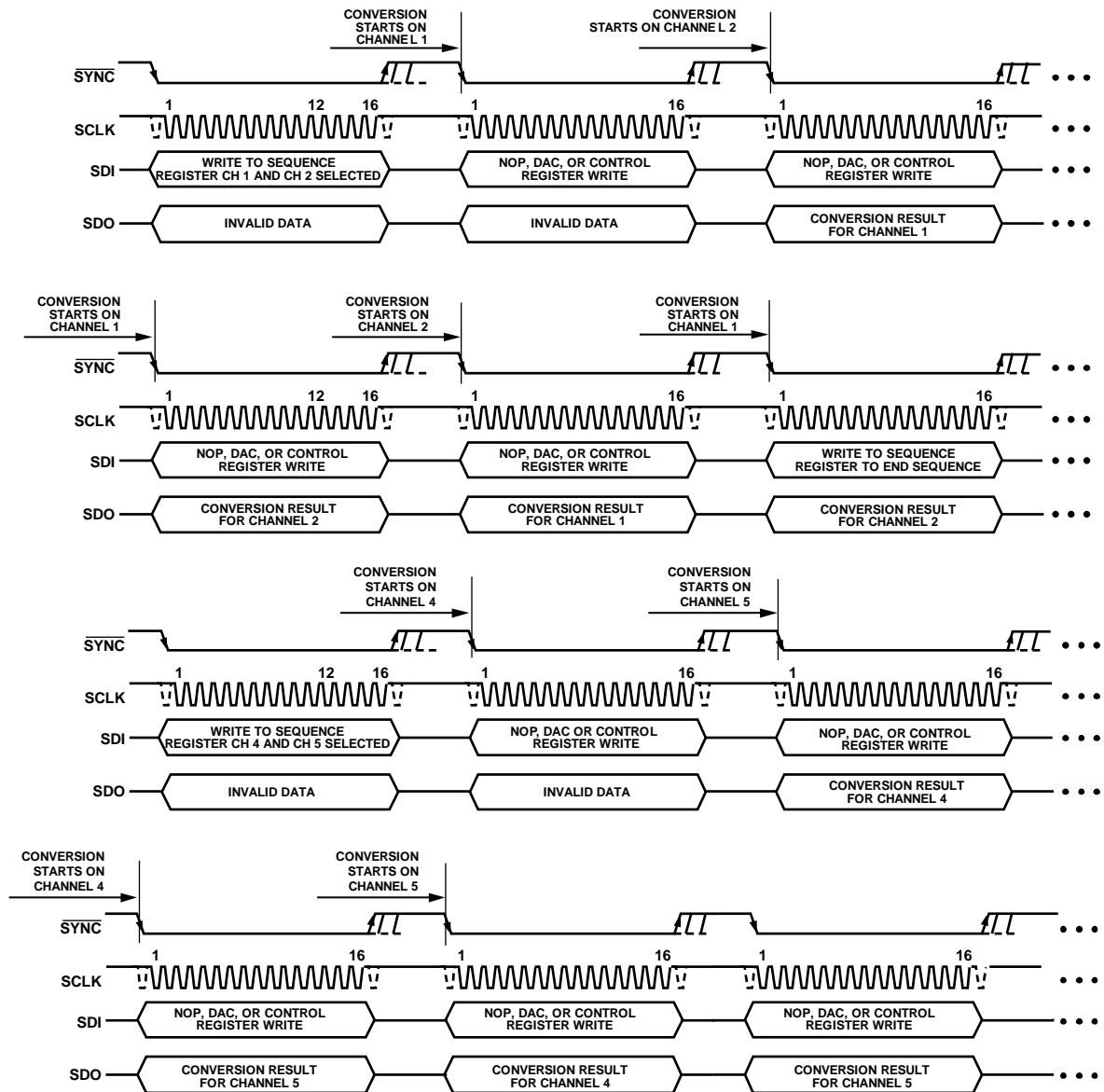


Figure 46. Changing a Multichannel, Repeating, ADC Conversion Sequence

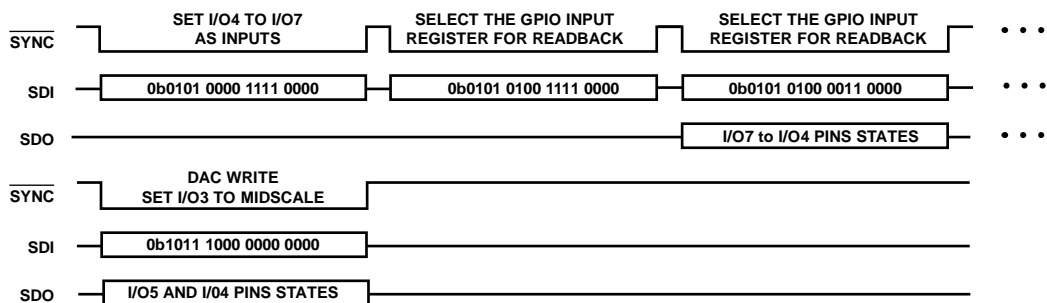


Figure 47. Configuring and Reading General-Purpose Input Pins

## GPIO OPERATION

Each of the I/Ox pins of the AD5592R/AD5592R-1 can operate as a general-purpose, digital input or output pin. The function of the pins is determined by writing to the appropriate bit in the GPIO read configuration and GPIO write configuration registers.

### Setting Pins as Outputs

To set a pin as a general-purpose output, set the appropriate bit in the GPIO write configuration register to 1 (see Table 30 and Table 31). For example, setting Bit 0 to Bit 1 enables I/O0 as a general-purpose output. The state of the output pin is controlled by setting or clearing the bits in the GPIO write data register (see Table 34). A data bit is ignored if it is written to a location that is not configured as an output.

The outputs can be independently configured as push/pull or open-drain outputs. When in a push/pull configuration, the output is driven to  $V_{DD}$  or GND, as determined by the data in the GPIO write data register. To set a pin as an open-drain output, set the appropriate bit in the GPIO open-drain configuration register to 1 (see Table 32 and Table 33). When in an open-drain configuration, the output is driven to GND when a data bit in the GPIO write data register sets the pin low. When the pin is set high, the output is not driven and must be pulled high by an external resistor. Open-drain configuration allows for multiple output pins to be tied together. If all the pins are normally high,

the open-drain configuration allows for one pin to pull down the others pins. This method is commonly used where multiple pins are used to trigger an alarm or an interrupt pin.

To change the state of the I/Ox pins, a write to the GPIO write data register is required. Setting a bit to 1 gives a Logic 1 on the selected output. Clearing a bit to 0 gives a Logic 0 on the selected output.

### Setting Pins as Inputs

To set a pin as a general-purpose input, set the appropriate bit in the GPIO read configuration register to 1 (see Table 36 and Table 37). For example, setting Bit 0 to Bit 1 enables I/O0 as a general-purpose input. To read the state of the general-purpose inputs, write to the GPIO read and configuration register to set Bit D10 to 1 and also any of Bit D7 to Bit D0 that correspond to a general-purpose input pin. The following SPI operation clocks out the state of any pins set as general-purpose inputs. Figure 47 shows an example where I/O4 to I/O7 are set as general-purpose inputs. I/O3 is assumed to be a DAC. To read the status of I/O7 to I/O4, Bit D10 and Bit D7 to Bit D4 are set to 1. To read the status of I/O5 and I/O4, only Bit D10, Bit D5, and Bit D4 need to be set to 1. The status of I/O7 and I/O6 are not read, and Bit D7 and Bit D6 are read as 0. Figure 47 also has a write to a DAC to show that other operations can be included when reading the status of the general-purpose pins.

Table 30. GPIO Write Configuration Register

| MSB |                  |     |     |     |          |    |             |       |       |       |       |       |       |       | LSB   |  |
|-----|------------------|-----|-----|-----|----------|----|-------------|-------|-------|-------|-------|-------|-------|-------|-------|--|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8          | D7    | D6    | D5    | D4    | D3    | D2    | D1    | D0    |  |
| 0   | Register address |     |     |     | Reserved |    | Enable BUSY | GPIO7 | GPIO6 | GPIO5 | GPIO4 | GPIO3 | GPIO2 | GPIO1 | GPIO0 |  |

Table 31. Bit Descriptions for the GPIO Write Configuration Register

| Bit(s)     | Bit Name                        | Description   |
|------------|---------------------------------|---|
| D15        | MSB                             | Set this bit to 0.  |
| D14 to D11 | Register address                | Set these bits to 0b1000.   |
| D10 to D9  | Reserved                        | Reserved. Set this bit to 0.  |
| D8         | Enable $\overline{\text{BUSY}}$ | Enable the I/O7 pin as $\overline{\text{BUSY}}$ .<br>0: Pin I/O7 is not configured as $\overline{\text{BUSY}}$ .<br>1: Pin I/O7 is configured as $\overline{\text{BUSY}}$ . D7 must also be set to 1 to enable the I/O7 pin as an output. |
| D7 to D0   | GPIO7 to GPIO0                  | Select I/Ox pins as GPIO outputs.<br>1: I/Ox is a general-purpose output pin.<br>0: I/Ox function is determined by the pin configuration registers (default).   |

Table 32. GPIO Open-Drain Configuration Register

| MSB |                  |     |     |     |          |    |    |              |              | LSB          |              |              |              |              |              |
|-----|------------------|-----|-----|-----|----------|----|----|--------------|--------------|--------------|--------------|--------------|--------------|--------------|--------------|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8 | D7           | D6           | D5           | D4           | D3           | D2           | D1           | D0           |
| 0   | Register address |     |     |     | Reserved |    |    | Open Drain 7 | Open Drain 6 | Open Drain 5 | Open Drain 4 | Open Drain 3 | Open Drain 2 | Open Drain 1 | Open Drain 0 |

Table 33. Bit Descriptions for the GPIO Open-Drain Configuration Register

| Bit(s)     | Bit Name                     | Description  |
|------------|------------------------------|--|
| D15        | MSB                          | Set this bit to 0.   |
| D14 to D11 | Register address             | Set these bits to 0b1100.  |
| D10 to D8  | Reserved                     | Reserved. Set these bits to 0.   |
| D7 to D0   | Open Drain 7 to Open Drain 0 | Set output pins as open-drain. The pins must also be set as digital output pins. See Table 31.<br>1: I/Ox is an open-drain output pin.<br>0: I/Ox is a push/pull output pin (default). |

Table 34. GPIO Write Data Register

| MSB |                  |     |     |     |          |    |    |       |       | LSB   |       |       |       |       |       |
|-----|------------------|-----|-----|-----|----------|----|----|-------|-------|-------|-------|-------|-------|-------|-------|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8 | D7    | D6    | D5    | D4    | D3    | D2    | D1    | D0    |
| 0   | Register address |     |     |     | Reserved |    |    | GPIO7 | GPIO6 | GPIO5 | GPIO4 | GPIO3 | GPIO2 | GPIO1 | GPIO0 |

Table 35. Bit Descriptions for the GPIO Write Data Register

| Bit(s)     | Bit Name         | Description   |
|------------|------------------|---|
| D15        | MSB              | Set this bit to 0.  |
| D14 to D11 | Register address | Set these bits to 0b1001.   |
| D10 to D8  | Reserved         | Reserved. Set these bits to 0.  |
| D7 to D0   | GPIO7 to GPIO0   | Set state of output pins.<br>1: I/Ox is a Logic 1.<br>0: I/Ox is a Logic 0. |

Table 36. GPIO Read Configuration Register

| MSB |                  |     |     |     |                 |          |    |       |       | LSB   |       |       |       |       |       |
|-----|------------------|-----|-----|-----|-----------------|----------|----|-------|-------|-------|-------|-------|-------|-------|-------|
| D15 | D14              | D13 | D12 | D11 | D10             | D9       | D8 | D7    | D6    | D5    | D4    | D3    | D2    | D1    | D0    |
| 0   | Register address |     |     |     | Enable readback | Reserved |    | GPIO7 | GPIO6 | GPIO5 | GPIO4 | GPIO3 | GPIO2 | GPIO1 | GPIO0 |

Table 37. Bit Descriptions for the GPIO Read Configuration Register

| Bit(s)     | Bit Name         | Description  |
|------------|------------------|--|
| D15        | MSB              | Set this bit to 0.   |
| D14 to D11 | Register address | Set these bits to 0b1010.  |
| D10        | Enable readback  | Enable GPIO readback.<br>1: the next SPI operation clocks out the state of the GPIO pins.<br>0: Bit D7 to Bit D0 determine which pins are set as general-purpose inputs. |
| D9 to D8   | Reserved         | Reserved. Set these bits to 0.   |
| D7 to D0   | GPIO7 to GPIO0   | Set I/Ox pins as GPIO inputs.<br>1: I/Ox is a general-purpose input pin.<br>0: I/Ox function is determined by the pin configuration registers (default).                 |

**THREE-STATE PINS**

The I/Ox pins can be set to three-state by writing to the three-state configuration register, as shown in Table 38 and Table 39.

**85 kΩ PULL-DOWN RESISTOR PINS**

The I/Ox pins can be connected to GND via a pull-down resistor (85 kΩ) by setting the appropriate bits in the pull-down configuration register, as shown in Table 40 and Table 41.

**Table 38. Three-State Configuration Register**

| MSB |                  |     |     |     |          |    |    |      |      |      | LSB  |      |      |      |     |
|-----|------------------|-----|-----|-----|----------|----|----|------|------|------|------|------|------|------|-----|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8 | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0  |
| 0   | Register address |     |     |     | Reserved |    |    | TSO7 | TSO6 | TSO5 | TSO4 | TSO3 | TSO2 | TSO1 | TSO |

**Table 39. Bit Descriptions for the Three-State Configuration Register**

| Bit(s)     | Bit Name         | Description   |
|------------|------------------|---|
| D15        | MSB              | Set this bit to 0.  |
| D14 to D11 | Register address | Set these bits to 0b1101.   |
| D10 to D8  | Reserved         | Reserved. Set these bits to 0.  |
| D7 to D0   | TSO7 to TSO0     | Set I/Ox pins as three-state outputs.<br>1: I/Ox is a three-state output pin.<br>0: I/Ox function is determined by the pin configuration registers (default). |

**Table 40. Pull-Down Configuration Register**

| MSB |                  |     |     |     |          |    |    |             |             |             | LSB         |             |             |             |             |
|-----|------------------|-----|-----|-----|----------|----|----|-------------|-------------|-------------|-------------|-------------|-------------|-------------|-------------|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8 | D7          | D6          | D5          | D4          | D3          | D2          | D1          | D0          |
| 0   | Register address |     |     |     | Reserved |    |    | Pull Down 7 | Pull Down 6 | Pull Down 5 | Pull Down 4 | Pull Down 3 | Pull Down 2 | Pull Down 1 | Pull Down 0 |

**Table 41. Bit Descriptions for the Pull-Down Configuration Register**

| Bit(s)     | Bit Name                   | Description  |
|------------|----------------------------|--|
| D15        | MSB                        | Set this bit to 0.   |
| D14 to D11 | Register address           | Set these bits to 0b0110.  |
| D10 to D8  | Reserved                   | Reserved. Set these bits to 0.   |
| D7 to D0   | Pull Down 7 to Pull Down 0 | Set I/Ox pins as weak pull-down outputs.<br>1: I/Ox is connected to GND via an 85 kΩ pull-down resistor.<br>0: I/Ox function is determined by the pin configuration registers (default). |

## POWER-DOWN MODE

The AD5592R/AD5592R-1 have a power configuration register to reduce the power consumption when certain functions are not needed. The power-down register allows any channels set as DACs to be individually placed in a power-down state.

When in a power-down state, the DAC outputs are three-state. When a DAC channel is put back into normal mode, the DAC output returns to its previous value. The internal reference and

its buffer are powered down by default and are enabled by setting the EN\_REF bit in the power-down register. The internal reference voltage then appears at the  $V_{REF}$  pin.

There is no dedicated power-down function for the ADC, but the ADC is automatically powered down if none of the I/Ox pins are selected as ADCs. The PD\_ALL bit powers down all the DACs, the reference and its buffer, and the ADC simultaneously. Table 42 and Table 43 show the power-down register.

**Table 42. Power-Down/Reference Control Register**

| MSB |                  |     |     |     |        |        |          |     |     |     |     |     |     | LSB |     |
|-----|------------------|-----|-----|-----|--------|--------|----------|-----|-----|-----|-----|-----|-----|-----|-----|
| D15 | D14              | D13 | D12 | D11 | D10    | D9     | D8       | D7  | D6  | D5  | D4  | D3  | D2  | D1  | D0  |
| 0   | Register address |     |     |     | PD_ALL | EN_REF | Reserved | PD7 | PD6 | PD5 | PD4 | PD3 | PD2 | PD1 | PD0 |

**Table 43. Bit Descriptions for the Power-Down/Reference Control Register**

| Bit(s)     | Bit Name         | Description  |
|------------|------------------|--|
| D15        | MSB              | Set this bit to 0.   |
| D14 to D11 | Register address | Set these bits to 0b1011.  |
| D10        | PD_ALL           | Power down DACs and internal reference.<br>0: the reference and DACs power-down states are determined by D9 and D7 to D0 (default).<br>1: the reference, DACs and ADC are powered down.  |
| D9         | EN_REF           | Enable internal reference.<br>0: the reference and its buffer are powered down (default). Set this bit if an external reference is used.<br>1: the reference and its buffer are powered up. The reference is available on the $V_{REF}$ pin. |
| D8         | Reserved         | Reserved. Set this bit to 0.   |
| D7 to D0   | PD7 to PD0       | Power down DACs.<br>0: the channel is in normal operating mode (default).<br>1: the channel is powered down if it is configured as a DAC.  |

## RESET FUNCTION

The [AD5592R/AD5592R-1](#) can be reset to their default conditions by writing to the reset register, as shown in Table 44. This write resets all registers to their default values and reconfigures the I/O pins to their default values (85 k $\Omega$  pull-down resistor to GND). The reset function takes 250  $\mu$ s maximum; do not write new data to the [AD5592R/AD5592R-1](#) during this time. The [AD5592R](#) has a  $\overline{\text{RESET}}$  pin that performs the same function. For normal operation,  $\overline{\text{RESET}}$  is tied high. A falling edge on  $\overline{\text{RESET}}$  triggers the reset function.

**Table 44. Software Reset**

| MSB                    |     |                         |     |     |     |   |    |    |    |    |    |    |    | LSB |    |
|------------------------|-----|-------------------------|-----|-----|-----|---|----|----|----|----|----|----|----|-----|----|
| D15                    | D14 | D13                     | D12 | D11 | D10 | D9  | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1  | D0 |
| 0                      | 1   | 1                       | 1   | 1   | 1   | 0   | 1  | 1  | 0  | 1  | 0  | 1  | 1  | 0   | 0  |
| Control register write |     | Write to reset register |     |     |     | Reset the <a href="#">AD5592R/AD5592R-1</a> |    |    |    |    |    |    |    |     |    |

**Table 45. Readback and LDAC Mode Register**

| MSB |                  |     |     |     |          |    |    |    |    |              |    |    |    | LSB       |    |
|-----|------------------|-----|-----|-----|----------|----|----|----|----|--------------|----|----|----|-----------|----|
| D15 | D14              | D13 | D12 | D11 | D10      | D9 | D8 | D7 | D6 | D5           | D4 | D3 | D2 | D1        | D0 |
| 0   | Register address |     |     |     | Reserved |    |    |    | EN | REG_READBACK |    |    |    | LDAC mode |    |

## READBAC AND LDAC MODE REGISTER

The values contained in the [AD5592R/AD5592R-1](#) registers can be read back to ensure that the registers are correctly set up. The register readback is initiated by writing to the readback and LDAC mode register with Bit D6 set to 1. Bit D5 to Bit D2 select which register is to be read back. The register data is clocked out of the [AD5592R/AD5592R-1](#) on the next SPI transfer.

Bit D1 to Bit D0 of the readback and LDAC mode register select the LDAC mode. The LDAC mode determines if data written to a DAC input register is also transferred to the DAC register. See the LDAC Mode Operation section for details of the LDAC mode function.



Table 46. Bit Descriptions for the Readback and LDAC Mode Register

| Bit(s)     | Bit Name         | Description  |
|------------|------------------|--|
| D15        | MSB              | Set this bit to 0.   |
| D14 to D11 | Register address | Set these bits to 0b0111.  |
| D10 to D7  | Reserved         | Reserved. Set these bits to 0.   |
| D6         | EN               | Enable readback. Note that the LDAC mode bits are always used regardless of the EN bit.<br>1: Bit D5 to Bit D2 select which register is read back. Bit D6 automatically clears when the read is complete.<br>0: no readback is initiated.  |
| D5 to D2   | REG_READBACK     | If Bit D6 is 1, Bits D5 to Bit D2 determine which register is to be read back.<br>0000: NOP.<br>0001: DAC readback.<br>0010: ADC sequence.<br>0011: general-purpose configuration.<br>0100: ADC pin configuration.<br>0101: DAC pin configuration.<br>0110: pull-down configuration.<br>0111: LDAC configuration.<br>1000: GPIO write configuration.<br>1001: GPIO write data.<br>1010: GPIO read configuration.<br>1011: power-down and reference control.<br>1100: open-drain configuration.<br>1101: three-state pin configuration.<br>1110: reserved.<br>1111: software reset. |
| D1 to D0   | LDAC mode        | Determines how data written to an input register of a DAC is handled.<br>00: data written to an input register is immediately copied to a DAC register, and the DAC output updates (default).<br>01: data written to an input register is not copied to a DAC register. The DAC output is not updated.<br>10: data in the input registers is copied to the corresponding DAC registers. When the data has been transferred, the DAC outputs are updated simultaneously.<br>11: reserved.   |

## APPLICATIONS INFORMATION

### MICROPROCESSOR INTERFACING

Microprocessor interfacing to the [AD5592R/AD5592R-1](#) is via a serial bus that uses a standard protocol compatible with DSPs and microcontrollers. The communications channel requires a 4-wire interface consisting of a clock signal, a data input signal, a data output signal, and a synchronization signal. The devices require a 16-bit data-word with data valid on the falling edge of SCLK.

### AD5592R/AD5592R-1 TO SPI INTERFACE

The SPI interface of the [AD5592R/AD5592R-1](#) is designed to be easily connected to industry-standard DSPs and microcontrollers. Figure 48 shows the [AD5592R/AD5592R-1](#) connected to the Analog Devices, Inc., [ADSP-BF531](#) Blackfin® DSP. The Blackfin has an integrated SPI port that can be connected directly to the SPI pins of the [AD5592R/AD5592R-1](#).

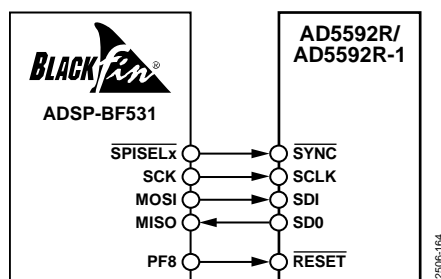


Figure 48. [ADSP-BF531](#) SPI Interface

### AD5592R/AD5592R-1 TO SPORT INTERFACE

The Analog Devices [ADSP-BF527](#) has two serial ports (SPORT). Figure 49 shows how a SPORT interface can be used to control the [AD5592R/AD5592R-1](#). The [ADSP-BF527](#) has an SPI port that can also be used. This method is the same as when using the [ADSP-BF531](#).

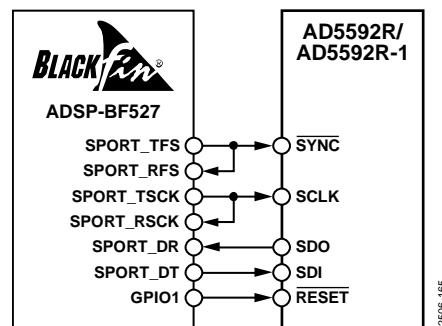


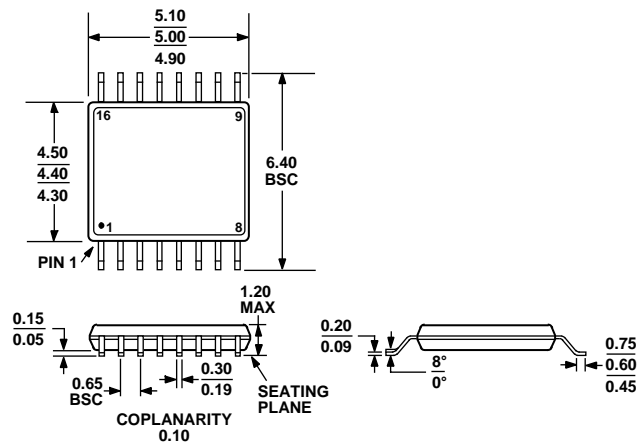
Figure 49. [ADSP-BF527](#) SPORT Interface

### LAYOUT GUIDELINES

In any circuit where accuracy is important, careful consideration of the power supply and ground return layout helps to ensure the rated performance. The printed circuit board (PCB) on which the [AD5592R](#) or the [AD5592R-1](#) is mounted must be designed so that the [AD5592R/AD5592R-1](#) lie on the analog plane.

The [AD5592R/AD5592R-1](#) must have ample supply bypassing of 10  $\mu\text{F}$  in parallel with 0.1  $\mu\text{F}$  on each supply, located as close to the package as possible, ideally right up against the device. The 10  $\mu\text{F}$  capacitors are the tantalum bead type. The 0.1  $\mu\text{F}$  capacitor must have low effective series resistance (ESR) and low effective series inductance (ESI). Ceramic capacitors, for example, provide a low impedance path to ground at high frequencies to handle transient currents due to internal logic switching.

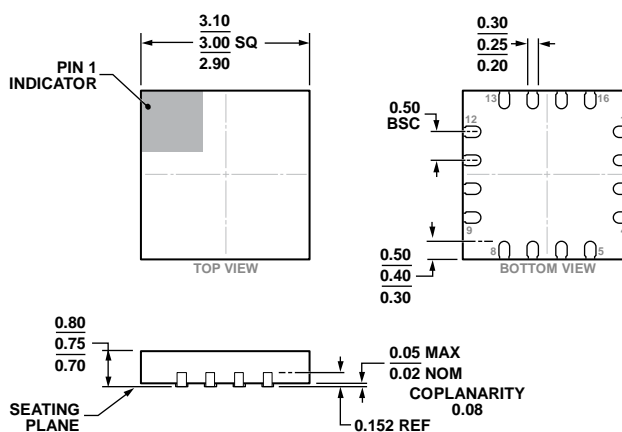
## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-153-AB

Figure 50. 16-Lead Thin Shrink Small Outline Package [TSSOP]  
(RU-16)

Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-220-WEED.

Figure 51. 16-Lead Lead Frame Chip Scale Package [LFCSP\_WQ]  
3 mm x 3 mm Body, Very Very Thin Quad  
(CP-16-32)

Dimensions shown in millimeters

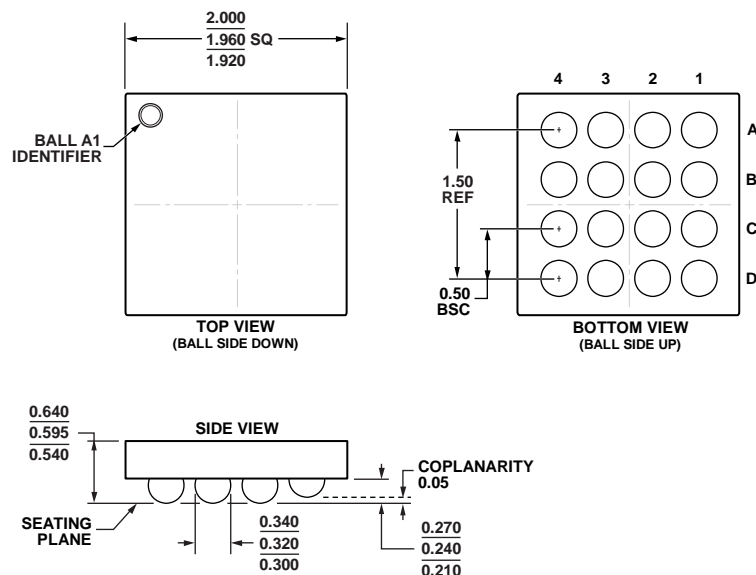


Figure 52. 16-Ball Wafer Level Chip Scale Package [WLCSP]  
(CB-16-3)  
Dimensions shown in millimeters

10-17-2012-B

## ORDERING GUIDE

| Model <sup>1</sup> | Temperature Range | Package Description                               | Package Option | Marking Code |
|--------------------|-------------------|---|----------------|--------------|
| AD5592RBCBZ-1-RL7  | −40°C to +105°C   | 16-Ball Wafer Level Chip Scale Package [WLCSP]    | CB-16-3        | DMD          |
| AD5592RBCPZ-1-RL7  | −40°C to +105°C   | 16-Lead Lead Frame Chip Scale Package [LFCSP_WQ]  | CP-16-32       |              |
| AD5592RBRUZ        | −40°C to +105°C   | 16-Lead Thin Shrink Small Outline Package [TSSOP] | RU-16          |              |
| AD5592RBRUZ-RL7    | −40°C to +105°C   | 16-Lead Thin Shrink Small Outline Package [TSSOP] | RU-16          |              |
| AD5592RBCBZ-RL7    | −40°C to +105°C   | 16-Ball Wafer Level Chip Scale Package [WLCSP]    | CB-16-3        | DMG          |
| AD5592RBCPZ-RL7    | −40°C to +105°C   | 16-Lead Lead Frame Chip Scale Package [LFCSP_WQ]  | CP-16-32       |              |
| EVAL-AD5592R-1SDZ  |                   | Evaluation Board                                  |                |              |
| EVAL-SDP-CB1Z      |                   | Controller Board                                  |                |              |

<sup>1</sup> Z = RoHS Compliant Part.

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